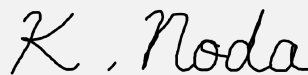


RADIO TEST REPORT

Test Report No. 15656421S-B-R1

Customer	JVCKENWOOD Corporation
Description of EUT	Monitor with receiver
Model Number of EUT	DAX800XR
FCC ID	IOMJ5309
Test Regulation	FCC Part 15 Subpart C
Test Result	Complied
Issue Date	March 11, 2025
Remarks	Bluetooth (BR / EDR) parts

Representative Test EngineerKouki Yamada
Engineer**Approved By**Kazuya Noda
Leader

CERTIFICATE 1266.03

- ☐ The testing in which "Non-accreditation" is displayed is outside the accreditation scopes in UL Japan, Inc.
- ☒ There is no testing item of "Non-accreditation".

Report Cover Page - Form-ULID-003532 (DCS:13-EM-F0429) Issue# 24.0

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- The results in this report apply only to the sample tested. (Laboratory was not involved in sampling.)
- This sample tested is in compliance with the limits of the above regulation.
- The test results in this test report are traceable to the national or international standards.
- This test report must not be used by the customer to claim product certification, approval, or endorsement by the A2LA accreditation body.
- This test report covers Radio technical requirements.
It does not cover administrative issues such as Manual or non-Radio test related Requirements. (if applicable)
- The all test items in this test report are conducted by UL Japan, Inc. Shonan EMC Lab.
- The opinions and the interpretations to the result of the description in this report are outside scopes where UL Japan, Inc. has been accredited.
- The information provided by the customer for this report is identified in SECTION 1.
- The laboratory is not responsible for information provided by the customer which can impact the validity of the results.
- For test report(s) referred in this report, the latest version (including any revisions) is always referred.

REVISION HISTORY

Original Test Report No. 15656421S-B

This report is a revised version of 15656421S-B. 15656421S-B is replaced with this report.

Revision	Test Report No.	Date	Page Revised Contents
- (Original)	15656421S-B	February 20, 2025	-
1	15656421S-B-R1	March 11, 2025	P.14 List of Cables Used <For Antenna Terminal Conducted test> No.1 to No.13 From: 0.1 m To: 0.15 m No.13 From: Unshielded To: Shielded P.18 Carrier Frequency Separation results corrected to MHz value.

Reference: Abbreviations (Including words undescribed in this report)

A2LA	The American Association for Laboratory Accreditation	IEC	International Electrotechnical Commission
AC	Alternating Current	IEEE	Institute of Electrical and Electronics Engineers
AFH	Adaptive Frequency Hopping	IF	Intermediate Frequency
AM	Amplitude Modulation	ILAC	International Laboratory Accreditation Conference
Amp, AMP	Amplifier	ISED	Innovation, Science and Economic Development Canada
ANSI	American National Standards Institute	ISO	International Organization for Standardization
Ant, ANT	Antenna	JAB	Japan Accreditation Board
AP	Access Point	LAN	Local Area Network
ASK	Amplitude Shift Keying	LIMS	Laboratory Information Management System
Atten., ATT	Attenuator	MCS	Modulation and Coding Scheme
AV	Average	MRA	Mutual Recognition Arrangement
BPSK	Binary Phase-Shift Keying	N/A	Not Applicable
BR	Bluetooth Basic Rate	NIST	National Institute of Standards and Technology
BT	Bluetooth	NS	No signal detect.
BT LE	Bluetooth Low Energy	NSA	Normalized Site Attenuation
BW	BandWidth	NVLAP	National Voluntary Laboratory Accreditation Program
Cal Int	Calibration Interval	OBW	Occupied Band Width
CCK	Complementary Code Keying	OFDM	Orthogonal Frequency Division Multiplexing
Ch., CH	Channel	OFDMA	Orthogonal Frequency Division Multiple Access
CISPR	Comite International Special des Perturbations Radioelectriques	P/M	Power meter
CW	Continuous Wave	PCB	Printed Circuit Board
DBPSK	Differential BPSK	PER	Packet Error Rate
DC	Direct Current	PHY	Physical Layer
D-factor	Distance factor	PK	Peak
DFS	Dynamic Frequency Selection	PN	Pseudo random Noise
DQPSK	Differential QPSK	PP	Preamble Puncturing
DSSS	Direct Sequence Spread Spectrum	PRBS	Pseudo-Random Bit Sequence
EDR	Enhanced Data Rate	PSD	Power Spectral Density
EIRP, e.i.r.p.	Equivalent Isotropically Radiated Power	QAM	Quadrature Amplitude Modulation
EMC	ElectroMagnetic Compatibility	QP	Quasi-Peak
EMI	ElectroMagnetic Interference	QPSK	Quadri-Phase Shift Keying
EN	European Norm	RBW	Resolution Band Width
ERP, e.r.p.	Effective Radiated Power	RDS	Radio Data System
EU	European Union	RE	Radio Equipment
EUT	Equipment Under Test	RF	Radio Frequency
Fac.	Factor	RMS	Root Mean Square
FCC	Federal Communications Commission	RSS	Radio Standards Specifications
FHSS	Frequency Hopping Spread Spectrum	Rx	Receiving
FM	Frequency Modulation	SA, S/A	Spectrum Analyzer
Freq.	Frequency	SG	Signal Generator
FSK	Frequency Shift Keying	SVSWR	Site-Voltage Standing Wave Ratio
GFSK	Gaussian Frequency-Shift Keying	TR	Test Receiver
GNSS	Global Navigation Satellite System	Tx	Transmitting
GPS	Global Positioning System	VBW	Video BandWidth
Hori.	Horizontal	Vert.	Vertical
ICES	Interference-Causing Equipment Standard	WLAN	Wireless LAN

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SECTION 1: Customer Information

Company Name	JVCKENWOOD Corporation
Address	3-12, Moriya-cho, Kanagawa-ku, Yokohama, Kanagawa, 221-0022 Japan
Telephone Number	+81-45-450-2769
Contact Person	Seigo Tsutsumi

The information provided by the customer is as follows;

- Customer, Description of EUT, Model Number of EUT, FCC ID on the cover and other relevant pages
- Operating/Test Mode(s) (Mode(s)) on all the relevant pages
- SECTION 1: Customer Information
- SECTION 2: Equipment Under Test (EUT) other than the Receipt Date and Test Date
- SECTION 4: Operation of EUT during testing

SECTION 2: Equipment Under Test (EUT)

2.1 Identification of EUT

Description	Monitor with receiver
Model Number	DAX800XR
Serial Number	Refer to SECTION 4.2
Condition	Production prototype (Not for Sale: This sample is equivalent to mass-produced items.)
Modification	No Modification by the test lab
Receipt Date	January 15, 2025
Test Date	January 17 to 29, 2025

2.2 Product Description

General Specification

Rating	DC 12 V
Operating temperature	-10 deg. C to +60 deg. C

Radio Specification

This report contains data provided by the customer which can impact the validity of results. UL Japan, Inc. is only responsible for the validity of results after the integration of the data provided by the customer. The data provided by the customer is marked "a)" in the table below.

WLAN (IEEE802.11b/11g/11n-20)

Equipment Type	Transceiver
Frequency of Operation	2412 MHz to 2462 MHz
Type of Modulation	DSSS, OFDM
Antenna Gain ^{a)}	-13.5 dBi

Bluetooth (BR / EDR)

Equipment Type	Transceiver
Frequency of Operation	2402 MHz to 2480 MHz
Type of Modulation	FHSS
Antenna Gain ^{a)}	-4.9 dBi

WLAN (IEEE802.11a/11n-20/11ac-20/11n-40/11ac-40/11ac-80)

Equipment Type	Transceiver	
Frequency of Operation	20 MHz Band	5745 MHz to 5805 MHz
	40 MHz Band	5755 MHz to 5795 MHz
	80 MHz Band	5775 MHz
Type of Modulation	OFDM	
Antenna Gain ^{a)}	ANT0: 2.5 dBi	
	ANT1: 2.3 dBi	

2.3 Valiant models

Model Number	Brand	Difference
DAX800XR	KENWOOD	Base
DAX1050XR	KENWOOD	10 inch Panel
DAX8000S	KENWOOD	8 inch Panel, None Digital Audio output
KW-Z1000AW	JVC	10 inch Panel, Key Volume, None Digital Audio output
KW-Z800AW	JVC	8 inch Panel, Key Volume, None Digital Audio output

SECTION 3: Test Specification, Procedures & Results

3.1 Test Specification

Test Specification	FCC Part 15 Subpart C The latest version on the first day of the testing period
Title	FCC 47 CFR Part 15 Radio Frequency Device Subpart C Intentional Radiators Section 15.207 Conducted limits Section 15.247 Operation within the bands 902-928 MHz, 2400-2483.5 MHz, and 5725-5850 MHz

* Also the EUT complies with FCC Part 15 Subpart B.

3.2 Procedures and Results

Item	Test Procedure	Specification	Worst Margin	Results	Remarks
Conducted Emission	FCC: ANSI C63.10-2013 6. Standard test methods ISED: RSS-Gen 8.8	FCC: Section 15.207 ISED: RSS-Gen 8.8	-	N/A	*1)
Carrier Frequency Separation	FCC: KDB 558074 D01 15.247 Meas Guidance v05r02 ISED: -	FCC: Section15.247(a)(1) ISED: RSS-247 5.1 (b)	See data.	Complied	Conducted
20dB Bandwidth	FCC: KDB 558074 D01 15.247 Meas Guidance v05r02 ISED: -	FCC: Section15.247(a)(1) ISED: RSS-247 5.1 (a)		Complied	Conducted
Number of Hopping Frequency	FCC: KDB 558074 D01 15.247 Meas Guidance v05r02 ISED: -	FCC: Section15.247(a)(1)(iii) ISED: RSS-247 5.1 (d)		Complied	Conducted
Dwell time	FCC: KDB 558074 D01 15.247 Meas Guidance v05r02 ISED: -	FCC: Section15.247(a)(1)(iii) ISED: RSS-247 5.1 (d)		Complied	Conducted
Maximum Peak Output Power	FCC: KDB 558074 D01 15.247 Meas Guidance v05r02 ISED: RSS-Gen 6.12	FCC: Section15.247(b)(1) ISED: RSS-247 5.4 (b)		Complied	Conducted
Spurious Emission & Band Edge Compliance	FCC: KDB 558074 D01 15.247 Meas Guidance v05r02 ISED: RSS-Gen 6.13	FCC: Section15.247(d) ISED: RSS-247 5.5 RSS-Gen 8.9 RSS-Gen 8.10	5.6 dB 393.214 MHz, QP, Horizontal Mode: Tx, DH5 2480 MHz with 11ac-80 5775 MHz	Complied	Conducted/ Radiated (above 30 MHz) *2)

Note: UL Japan, Inc.'s EMI Work Procedures: Work Instructions-ULID-003591 and Work Instructions-ULID-003593.

* In case any questions arise about test procedure, ANSI C63.10: 2013 is also referred.

*1) The test is not applicable since the EUT does not have AC Mains.

*2) Radiated test was selected over 30 MHz based on section 15.247(d).

FCC Part 15.31 (e)

This EUT provides the stable voltage constantly to RF Module regardless of input voltage. Instead of a new battery, DC power supply was used for the test. That does not affect the test result, therefore, this EUT complies with the requirement.

FCC Part 15.203 Antenna requirement

It is impossible for end users to replace the antenna, because the antenna is mounted inside of the EUT. Therefore, the equipment complies with the antenna requirement of Section 15.203.

3.3 Addition to Standard

Item	Test Procedure	Specification	Worst Margin	Results	Remarks
99% Occupied Bandwidth	ISED: RSS-Gen 6.7	ISED: -	N/A	-	Conducted

Other than above, no addition, exclusion nor deviation has been made from the standard.

3.4 Uncertainty

Measurement uncertainty is not taken into account when stating conformity with a specified requirement.

Note: When margins obtained from test results are less than the measurement uncertainty, the test results may exceed the limit.

The following uncertainties have been calculated to provide a confidence level of 95 % using a coverage factor $k = 2$.

Item	Frequency range	Uncertainty (+/-)
Conducted Emission (AC Mains) LISN	150 kHz to 30 MHz	3.0 dB
Radiated Emission (Measurement distance: 3 m)	9 kHz to 30 MHz	3.3 dB
	30 MHz to 200 MHz	4.8 dB
	200 MHz to 1 GHz	6.1 dB
	1 GHz to 6 GHz	4.7 dB
	6 GHz to 18 GHz	5.3 dB
	18 GHz to 40 GHz	5.5 dB
Radiated Emission (Measurement distance: 1 m)	1 GHz to 18 GHz	5.6 dB
	18 GHz to 40 GHz	5.8 dB

Antenna terminal test	Uncertainty (+/-)
Power Measurement above 1 GHz (Average Detector)	1.3 dB
Power Measurement above 1 GHz (Peak Detector)	1.5 dB
Spurious Emission (Conducted) below 1 GHz	0.93 dB
Conducted Emissions Power Density Measurement 1 GHz to 3 GHz	0.93 dB
Conducted Emissions Power Density Measurement 3 GHz to 18 GHz	3.0 dB
Spurious Emission (Conducted) 18 GHz to 26.5 GHz	2.8 dB
Spurious Emission (Conducted) 26.5 GHz to 40 GHz	2.3 dB
Bandwidth Measurement	0.012 %
Duty Cycle and Time Measurement	0.27 %
Temperature	2.2 deg.C.
Humidity	3.4 %
Voltage	0.92 %

3.5 Test Location

UL Japan, Inc. Shonan EMC Lab.

1-22-3, Megumigaoka, Hiratsuka-shi, Kanagawa-ken 259-1220 Japan

Telephone: +81-463-50-6400

A2LA Certificate Number: 1266.03

(FCC test firm registration number: 626366, ISED lab company number: 2973D / CAB identifier: JP0001)

Test room	Width x Depth x Height (m)	Size of reference ground plane (m) / horizontal conducting plane	Maximum measurement distance
No.1 Semi-anechoic chamber (SAC1)	20.6 x 11.3 x 7.65	20.6 x 11.3	10 m
No.2 Semi-anechoic chamber (SAC2)	20.6 x 11.3 x 7.65	20.6 x 11.3	10 m
No.3 Semi-anechoic chamber (SAC3)	12.7 x 7.7 x 5.35	12.7 x 7.7	5 m
No.4 Semi-anechoic chamber (SAC4)	8.1 x 5.1 x 3.55	8.1 x 5.1	-
Wireless anechoic chamber 1 (WAC1)	9.5 x 6.0 x 5.4	9.5 x 6.0	3 m
Wireless anechoic chamber 2 (WAC2)	9.5 x 6.0 x 5.4	9.5 x 6.0	3 m
No.1 Shielded room	6.8 x 4.1 x 2.7	6.8 x 4.1	-
No.2 Shielded room	6.8 x 4.1 x 2.7	6.8 x 4.1	-
No.3 Shielded room	6.3 x 4.7 x 2.7	6.3 x 4.7	-
No.4 Shielded room	4.4 x 4.7 x 2.7	4.4 x 4.7	-
No.5 Shielded room	7.8 x 6.4 x 2.7	7.8 x 6.4	-
No.6 Shielded room	7.8 x 6.4 x 2.7	7.8 x 6.4	-
No.8 Shielded room	3.45 x 5.5 x 2.4	3.45 x 5.5	-
No.1 Measurement room	2.55 x 4.1 x 2.5	-	-
No.2 Measurement room	4.5 x 3.5 x 2.5	-	-
Wireless shielded room 1	3.0 x 4.5 x 2.7	3.0 x 4.5	-
Wireless shielded room 2	3.0 x 4.5 x 2.7	3.0 x 4.5	-

3.6 Test Data, Test Instruments, and Test Set Up

Refer to APPENDIX.

SECTION 4: Operation of EUT during testing

4.1 Operating Mode(s)

Mode	Remarks*
Bluetooth (BT)	BR / EDR, Payload: PRBS9
*EUT has the power settings by the software as follows; Power Setting: Fixed Software: SoC : Version 0.0.1306.3200 System : Version 0.0.0059.4000 Panel : Version 0.0.0079.4000 (Date: 2025.01.17, Storage location: EUT memory) *This setting of software is the worst case. Any conditions under the normal use do not exceed the condition of setting. In addition, end users cannot change the settings of the output power of the product.	

Details of Operating Mode(s)

Test Item	Mode	Hopping	Tested Frequency
Radiated Spurious Emission (Below 1 GHz)	Tx DH5 *1)	Off	2441 MHz
Radiated Spurious Emission (Above 1 GHz), Conducted Spurious Emission	Tx DH5 Tx 3DH5	Off	2402 MHz 2441 MHz 2480 MHz
Radiated Spurious Emission	Tx DH5 with 11ac-80 5775 MHz	Off	2480 MHz
Radiated Spurious Emission (Band Edge)	Tx 3DH5 with 11ac-80 5775 MHz	Off	2480 MHz
Carrier Frequency Separation	Tx DH5 Tx 3DH5	On	2402 MHz 2441 MHz 2480 MHz
20dB Bandwidth	Tx DH5 Tx 3DH5	Off	2402 MHz 2441 MHz 2480 MHz
Number of Hopping Frequency	Tx DH5 Tx 3DH5	On	-
Dwell time	Tx DH1, DH3, DH5 Tx 3DH1, 3DH3, 3DH5	On	-
Maximum Peak Output Power	Tx DH5 Tx 2DH5 Tx 3DH5	Off	2402 MHz 2441 MHz 2480 MHz
Band Edge Compliance (Conducted)	Tx DH5 Tx 3DH5	On Off	2402 MHz 2480 MHz
99% Occupied Bandwidth	Tx DH5 Tx 3DH5	On Off	2402 MHz 2441 MHz 2480 MHz

*As a result of preliminary test, the formal test was performed with the above modes, which had the maximum payload length (except Dwell time test)

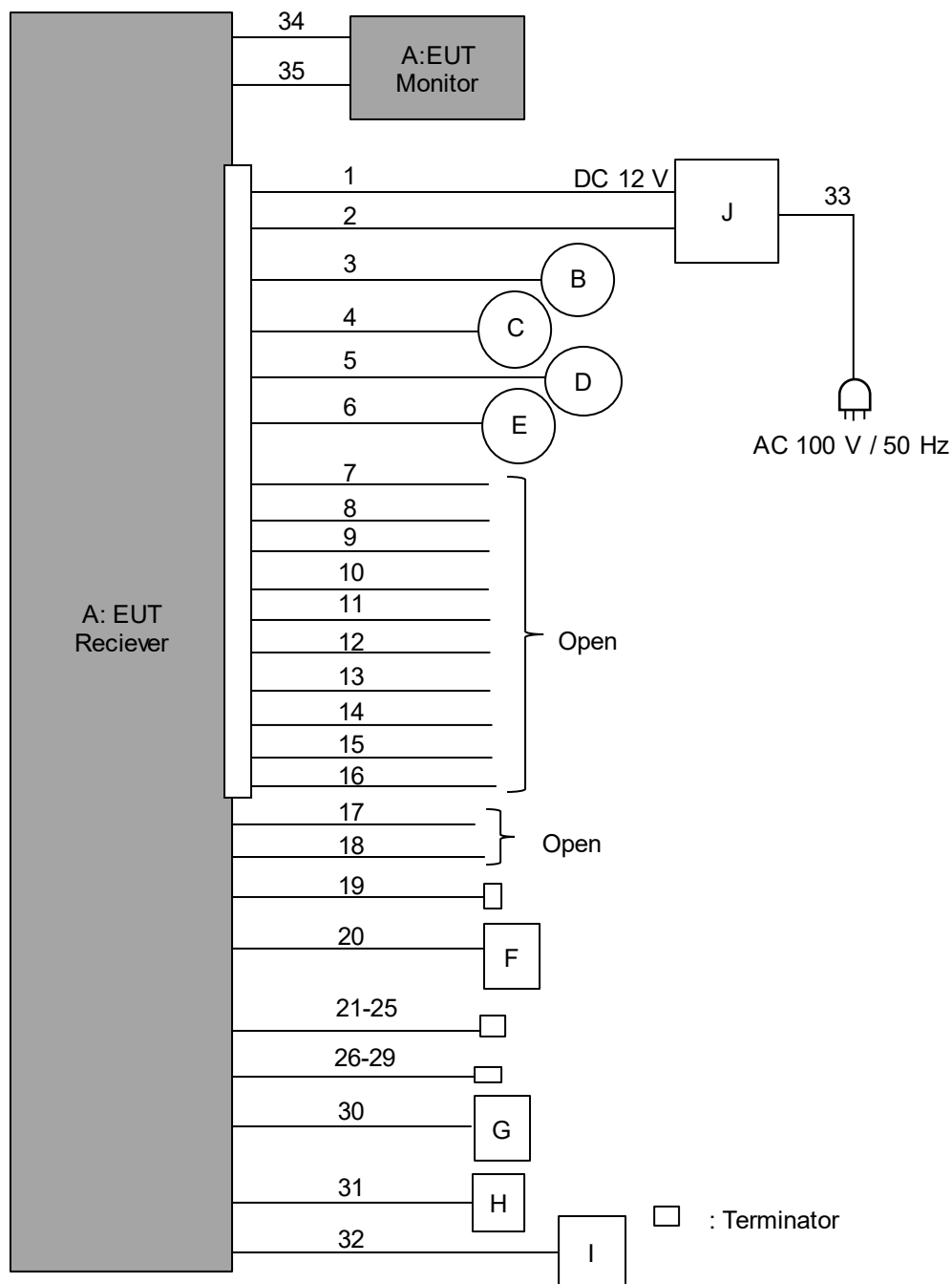
*2DH mode (2Mb/s EDR: pi/4DQPSK) was excluded for other tests than power measurement by using 3DH mode (3 Mb/s EDR: 8DPSK) as a representative.

*It is considered that the non-tested packet type (e.g. inquiry) can be omitted as it is complied with above all the test items based on Bluetooth Core specification.

*1) Spurious emissions for frequencies below 1 GHz were limited to the channel that had the highest power during the antenna terminal test, as preliminary testing indicated that changing the operating frequency had no significant impact on the emissions in those frequency bands.

4.2 Configuration and Peripherals

<For Radiated Emission test>



* Cabling and setup(s) were taken into consideration and test data was taken under worse case conditions.

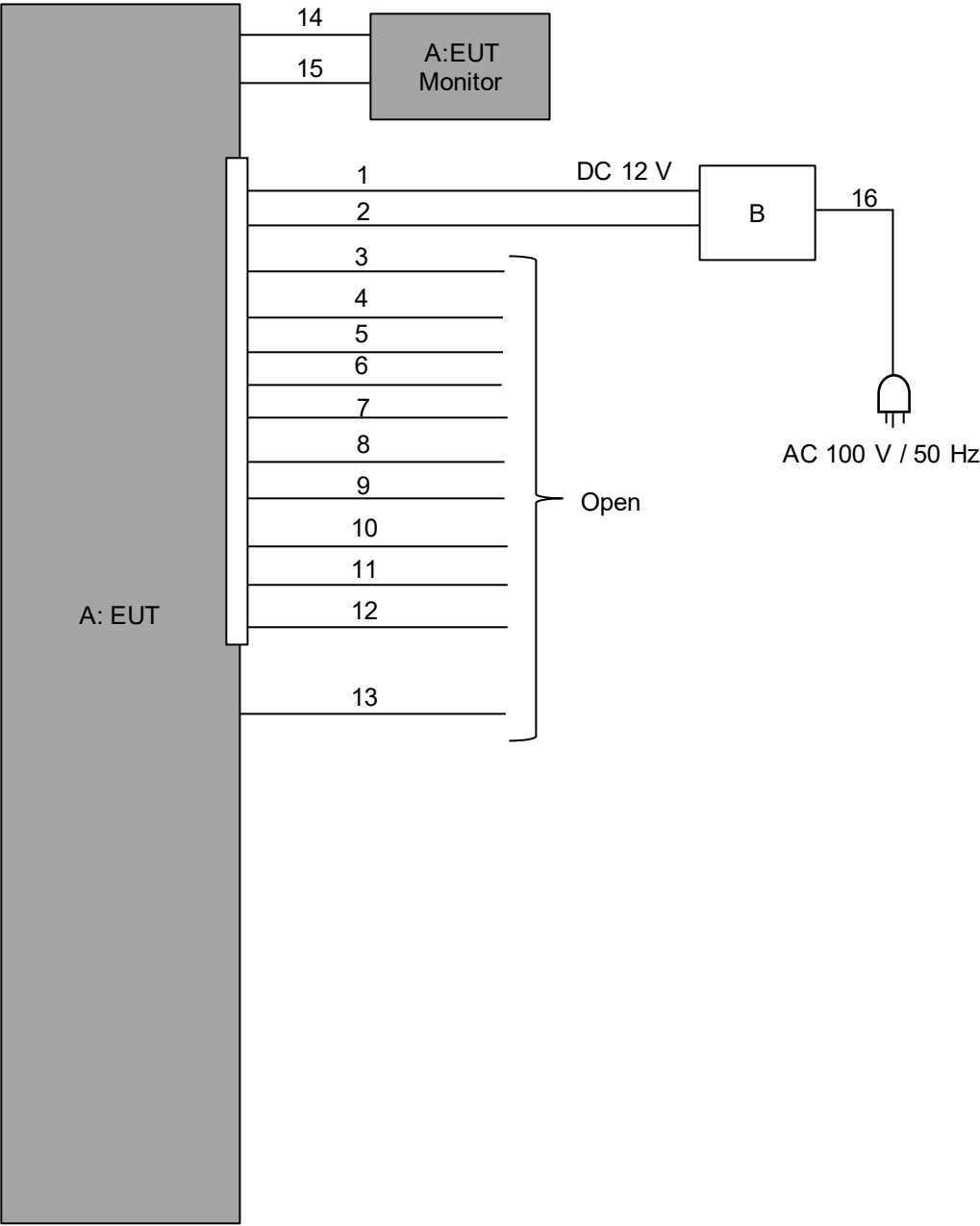
Description of EUT and Support Equipment

No.	Item	Model number	Serial number	Manufacturer	Remark
A	Monitor with Receiver	DAX800XR	PE-X0005	JVCKENWOOD	EUT
B	Speaker(car)	LV-002	S11014200775	L&V	-
C	Speaker(car)	LV-002	S11014200775	L&V	-
D	Speaker(car)	LV-002	S11014200773	L&V	-
E	Speaker(car)	LV-002	S11014200773	L&V	-
F	Microphone	GD-VHM421C	-	JVCKENWOD	-
G	GPS ANTENNA	GPA-GS211	-	JVCKENWOD	-
H	USB Memory	SDCZ810 383	BN22120037344	SanDisk	-
I	iPhone	MQ792J/A	C8PY95XLJC6H	APPLE INC.	-
J	Power Supply (DC)	PAN35-10A	CY003459	Kikusui Electronics Corp.	-

List of Cables Used

No.	Name	Length (m)	Shield		Remarks
			Cable	Connector	
1	DC (ACC, B+)	0.2 + 1.4	Unshielded	Unshielded	-
2	DC (GND)	0.2 + 1.4	Unshielded	Unshielded	-
3	Speaker (Front-L) +/-	0.15 + 1.6 + 2.8	Unshielded	Unshielded	-
4	Speaker (Front-R) +/-	0.15 + 1.6 + 2.8	Unshielded	Unshielded	-
5	Speaker (Rear-L) +/-	0.15 + 1.6 + 2.8	Unshielded	Unshielded	-
6	Speaker (Rear-R) +/-	0.15 + 1.6 + 2.8	Unshielded	Unshielded	-
7	ILLUMI	0.15 + 0.9	Unshielded	Unshielded	-
8	ANT Cont	0.15 + 0.9	Unshielded	Unshielded	-
9	P.CONT	0.15 + 0.9	Unshielded	Unshielded	-
10	REMOTE Cont	0.15 + 0.9	Unshielded	Unshielded	-
11	PRK SW	2.0	Unshielded	Unshielded	-
12	REVERSE	2.0	Unshielded	Unshielded	-
13	CAM+	0.15 + 0.9	Unshielded	Unshielded	-
14	CAM-	0.15 + 0.9	Unshielded	Unshielded	-
15	Mute	0.15 + 0.9	Unshielded	Unshielded	-
16	S.SENS	2.0	Unshielded	Unshielded	-
17	SXM IF	1.0	Shielded	Shielded	-
18	IF	1.0	Unshielded	Unshielded	-
19	FM/AM	0.15 + 1.8	Shielded	Shielded	-
20	Mic	3.0	Unshielded	Unshielded	-
21	Front View Camera	0.15 + 2.1	Shielded	Shielded	-
22	Rear View Camera	0.15 + 1.5	Shielded	Shielded	-
23	3rd View Camera	0.15 + 3.6	Shielded	Shielded	-
24	VIDEO IN	0.15 + 3.6	Shielded	Shielded	-
25	VIDEO OUT	0.2 + 3.6	Shielded	Shielded	-
26	AUDIO IN	0.2 + 3.5	Shielded	Shielded	-
27	AUDIO OUT Front	0.3 + 3.6	Shielded	Shielded	-
28	AUDIO OUT Rear	0.3 + 1.5	Shielded	Shielded	-
29	AUDIO OUT Subwoofer	0.3 + 1.5	Shielded	Shielded	-
30	GPS	3.4	Shielded	Shielded	-
31	USB	1.0	Shielded	Shielded	-
32	HDMI	1.7	Shielded	Shielded	-
33	AC	2.0	Unshielded	Unshielded	-
34	Signal	0.6	Shielded	Shielded	-
35	Signal	0.6	Shielded	Shielded	-

<For Antenna Terminal Conducted test>



Description of EUT and Support Equipment

No.	Item	Model number	Serial number	Manufacturer	Remark
A	Monitor with Receiver	DAX800XR	PK-X0001	JVCKENWOOD	EUT
B	Power Supply (DC)	PNA16-10A	ER001077	Kikusui Electronics Corp.	-

List of Cables Used

No.	Name	Length (m)	Shield		Remarks
			Cable	Connector	
1	DC (ACC, B+)	0.15+0.5	Unshielded	Unshielded	-
2	DC (GND)	0.15+0.5	Unshielded	Unshielded	-
3	Speaker (Front-L) +/-	0.15	Unshielded	Unshielded	-
4	Speaker (Front-R) +/-	0.15	Unshielded	Unshielded	-
5	Speaker (Rear-L) +/-	0.15	Unshielded	Unshielded	-
6	Speaker (Rear-R) +/-	0.15	Unshielded	Unshielded	-
7	ILLUMI	0.15	Unshielded	Unshielded	-
8	ANT Cont	0.15	Unshielded	Unshielded	-
9	Mute	0.15	Unshielded	Unshielded	-
10	REMOTE Cont	0.15	Unshielded	Unshielded	-
11	Reverse	0.15	Unshielded	Unshielded	-
12	P.Cont	0.15	Unshielded	Unshielded	-
13	FM/AM	0.15	Shielded	Shielded	-
14	Signal	0.6	Shielded	Shielded	-
15	Signal	0.6	Shielded	Shielded	-
16	AC	2.0	Unshielded	Unshielded	-

SECTION 5: Radiated Spurious Emission

Test Procedure

[For below 1 GHz]

EUT was placed on a urethane platform of nominal size, 1.0 m by 1.5 m, raised 0.8 m above the conducting ground plane. The Radiated Electric Field Strength has been measured in a Semi Anechoic Chamber with a ground plane.

[For above 1 GHz]

EUT was placed on a urethane platform of nominal size, 0.5 m by 0.5 m, raised 1.5 m above the conducting ground plane. The Radiated Electric Field Strength has been measured in a Semi Anechoic Chamber with absorbent materials lined on a ground plane. Test antenna was aimed at the EUT for receiving the maximum signal and always kept within the illumination area of the 3 dB beamwidth of the antenna.

The height of the measuring antenna varied between 1 m and 4 m and EUT was rotated a full revolution in order to obtain the maximum value of the electric field strength.

The measurements were performed for both vertical and horizontal antenna polarization with the Test Receiver, or the Spectrum Analyzer.

The measurements were made with the following detector function of the test receiver and the Spectrum analyzer (in linear mode).

The test was made with the detector (RBW/VBW) in the following table.

When using Spectrum analyzer, the test was made with adjusting span to zero by using peak hold.

Test Antennas are used as below;

Frequency	30 MHz to 200 MHz	200 MHz to 1 GHz	Above 1 GHz
Antenna Type	Biconical	Logperiodic	Horn

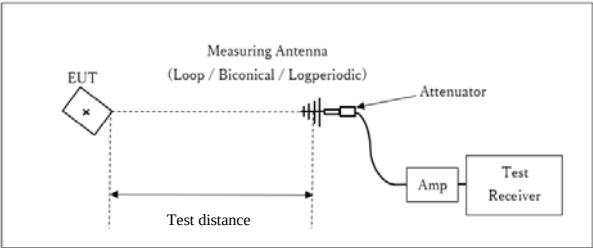
In any 100 kHz bandwidth outside the restricted band in which the spread spectrum intentional radiator is operating, the radio frequency power that is produced by the intentional radiator confirmed 20 dB below that in the 100 kHz bandwidth within the band that contains the highest level of the desired power, based on a radiated measurement.

20 dBc was applied to the frequency over the limit of FCC 15.209 / Table 4 of RSS-Gen 8.9 (ISED) and outside the restricted band of FCC15.205 / Table 6 of RSS-Gen 8.10 (ISED).

Frequency	Below 1 GHz	Above 1 GHz		20 dBc
Instrument used	Test Receiver	Spectrum Analyzer		Spectrum Analyzer
Detector	QP	PK	AV	PK
IF Bandwidth	BW 120 kHz	RBW: 1 MHz VBW: 3 MHz	RBW: 1 MHz VBW: 1/T (T: burst length, refer to Burst rate confirmation sheet) Detector: Peak	RBW: 100 kHz VBW: 300 kHz

Figure 2: Test Setup

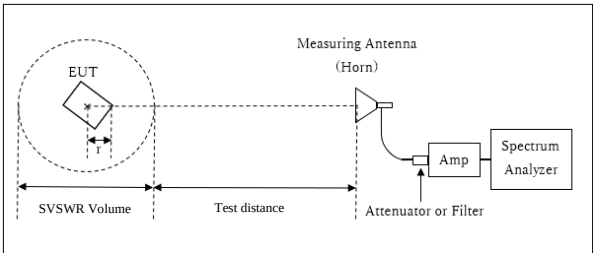
Below 1 GHz



x : Center of turn table

Test Distance: 3 m

1 GHz to 10 GHz

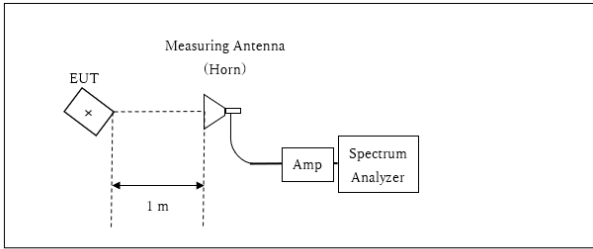


r : Radius of an outer periphery of EUT
x : Center of turn table

Distance Factor: $20 \times \log (3.89 \text{ m}^* / 3.0 \text{ m}) = 2.26 \text{ dB}$
*(Test Distance + SVSWR Volume / 2) - r = 3.89 m

Test Distance: 3 m
SVSWR Volume: 2 m
(SVSWR Volume has been calibrated based on CISPR 16-1-4.)
r: 0.11 m

10 GHz to 26.5 GHz



x : Center of turn table

Distance Factor: $20 \times \log (1.0 \text{ m} / 3.0 \text{ m}) = -9.54 \text{ dB}$
*Test Distance: 1 m

The test was made on EUT at the normal use position.

Test results are rounded off and limit are rounded down, so some differences might be observed.

Measurement Range	: 30 MHz to 26.5 GHz
Test Data	: APPENDIX
Test Result	: Pass

SECTION 6: Antenna Terminal Conducted Tests

Test Procedure

The tests were made with below setting connected to the antenna port.

Test	Span	RBW	VBW	Sweep time	Detector	Trace	Instrument Used
20 dB Bandwidth	3 MHz	30 kHz	100 kHz	Auto	Peak	Max Hold	Spectrum Analyzer
99 % Occupied Bandwidth *1)	Enough width to display emission skirts	1 to 5 % of OBW	Three times of RBW	Auto	Peak	Max Hold *1)	Spectrum Analyzer
Maximum Peak Output Power	-	-	-	Auto	Peak/Average *2)	-	Power Meter (Sensor: 160 MHz BW)
Carrier Frequency Separation	3 MHz	100 kHz	300 kHz	Auto	Peak	Max Hold	Spectrum Analyzer
Number of Hopping Frequency	30 MHz	100 kHz	300 kHz	Auto	Peak	Max Hold	Spectrum Analyzer
Dwell Time	Zero Span	100 kHz, 1 MHz	300 kHz, 3 MHz	As necessary capture the entire dwell time per hopping channel	Peak	Clear Write	Spectrum Analyzer
Conducted Spurious Emission *3) *4)	9 kHz to 150 kHz	200 Hz	620 Hz	Auto	Peak	Max Hold	Spectrum Analyzer
	150 kHz to 30 MHz	10 kHz	30 kHz				
	30 MHz to 25 GHz	100 kHz	300 kHz				
Conducted Spurious Emission Band Edge compliance	10 MHz	100 kHz	300 kHz	Auto	Peak	Max Hold	Spectrum Analyzer

*1) The measurement was performed with Max Hold since the duty cycle was not 100 %. Peak hold was applied as Worst-case measurement.

*2) Reference data

*3) In the frequency range below 30MHz, RBW was narrowed to separate the noise contents.

Then, wide-band noise near the limit was checked separately, however the noise was not detected as shown in the chart.

(9 kHz -150 kHz: RBW = 200 Hz, 150 kHz - 30 MHz: RBW = 10 kHz)

*4) The limits in CFR 47, Part 15, Subpart C, paragraph 15.209(a), are identical to those in RSS-Gen section 8.9, Table 6, since the measurements are performed in terms of magnetic field strength and converted to electric field strength levels (as reported in the table) using the free space impedance of 377 Ohms. For example, the measurement at frequency 9 kHz resulted in a level of 45.5 dBuV/m, which is equivalent to $45.5 - 51.5 = -6.0$ dBuA/m, which has the same margin, 3 dB, to the corresponding RSS-Gen Table 6 limit as it has to 15.209(a) limit.

Test results are rounded off and limit are rounded down, so some differences might be observed.
The equipment and cables were not used for factor 0 dB of the data sheets.

Test Data : APPENDIX
Test Result : Pass

APPENDIX 1: Test data

20dB Bandwidth, 99%Occupied Bandwidth and Carrier Frequency Separation

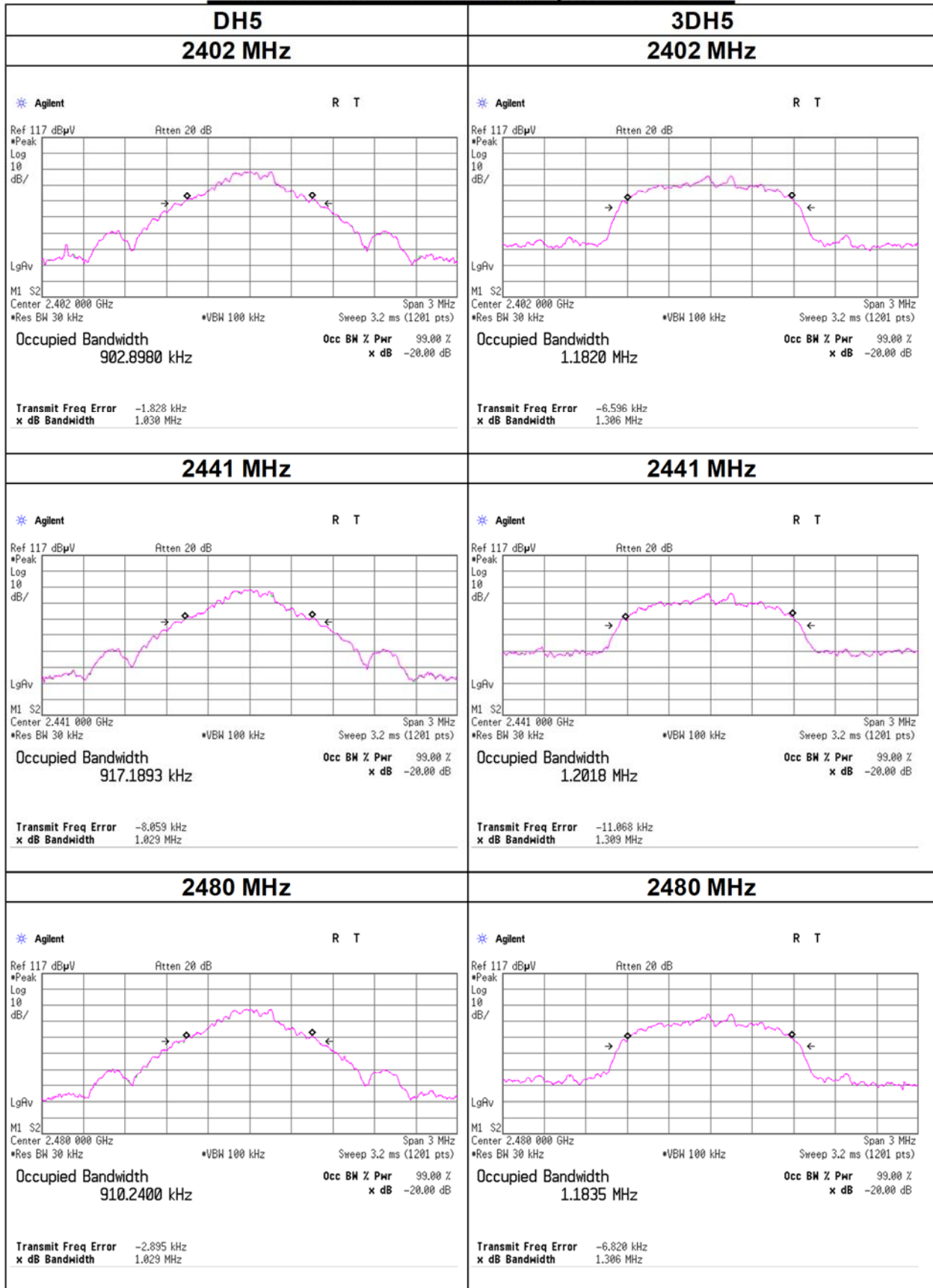
Test place	Shonan EMC Lab. No.5 Shielded Room
Date	January 22, 2025
Temperature / Humidity	21 deg. C / 40 % RH
Engineer	Yosuke Murakami
Mode	Tx, Hopping Off, Tx, Hopping On

Mode	Freq. [MHz]	20 dB Bandwidth [MHz]	99 % Occupied Bandwidth [kHz]	Carrier Frequency Separation [MHz]	Limit for Carrier Frequency separation [MHz]
DH5	2402.0	1.030	902.9	1.018	≥ 0.687
DH5	2441.0	1.029	917.2	0.978	≥ 0.686
DH5	2480.0	1.029	910.2	0.978	≥ 0.686
DH5	Hopping On	-	78583.0	-	-
3DH5	2402.0	1.306	1182.0	1.025	≥ 0.871
3DH5	2441.0	1.309	1201.8	1.158	≥ 0.873
3DH5	2480.0	1.306	1183.5	1.018	≥ 0.871
3DH5	Hopping On	-	78656.1	-	-

Limit: Two-thirds of 20 dB Bandwidth or 25 kHz (whichever is greater).

No limit applies to 20 dB Bandwidth.

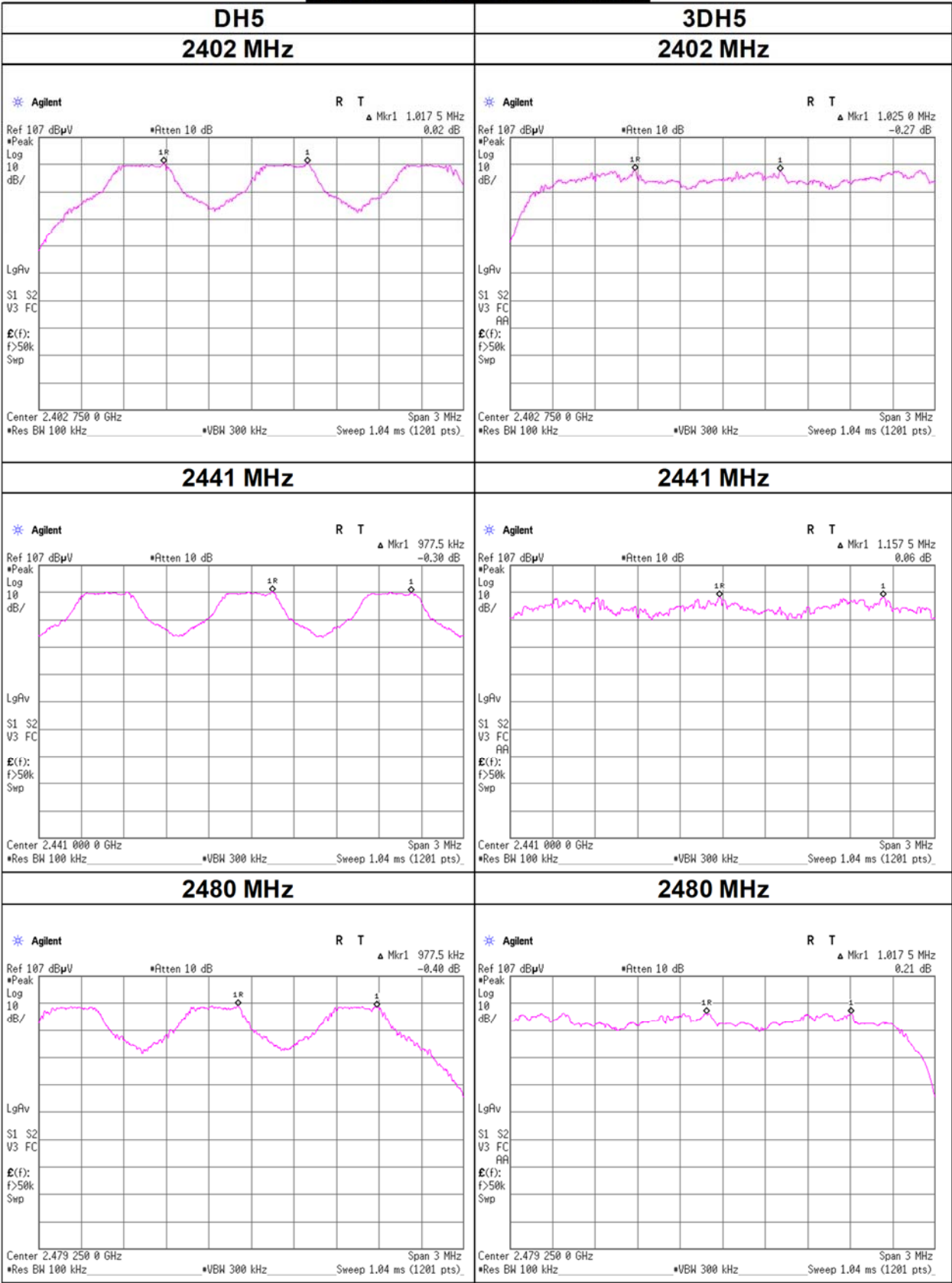
20 dB Bandwidth & 99 % Occupied Bandwidth



20 dB Bandwidth & 99 % Occupied Bandwidth



Carrier Frequency Separation



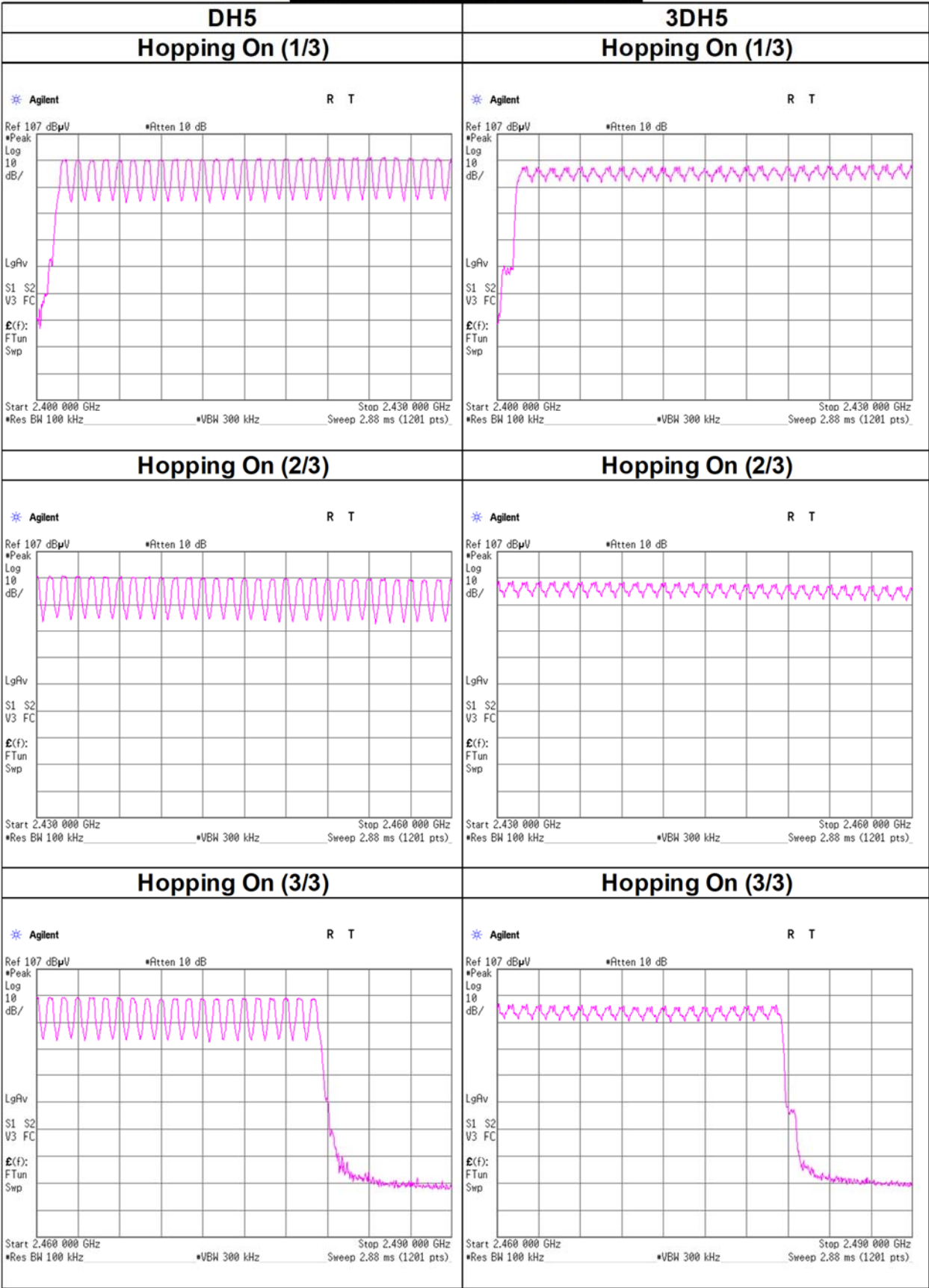
Number of Hopping Frequency

Test place Shonan EMC Lab. No.5 Shielded Room
Date January 22, 2025
Temperature / Humidity 21 deg. C / 40 % RH
Engineer Yosuke Murakami
Mode Tx, Hopping On

Mode	Number of channel [channels]	Limit [channels]
DH5	79	>= 15
3DH5	79	>= 15

Test was not performed at AFH mode whose number of hopping channel is
20 channels because this Bluetooth radio is in compliance of Bluetooth Specification.

Number of Hopping Frequency



Dwell time

Test place Shonan EMC Lab. No.5 Shielded Room
Date January 22, 2025
Temperature / Humidity 21 deg. C / 40 % RH
Engineer Yosuke Murakami
Mode Tx, Hopping On

Mode	Number of transmission in a 31.6 (79 Hopping x 0.4)	Length of transmission [ms]	Result [ms]	Limit [ms]
DH1	51.0 times / 5 s x 31.6 s = 323 times	0.401	129	400
DH3	25.2 times / 5 s x 31.6 s = 160 times	1.675	268	400
DH5	20.6 times / 5 s x 31.6 s = 131 times	2.910	381	400
3DH1	50.8 times / 5 s x 31.6 s = 322 times	0.408	131	400
3DH3	25.4 times / 5 s x 31.6 s = 161 times	1.664	268	400
3DH5	20.2 times / 5 s x 31.6 s = 128 times	2.917	373	400

Sample Calculation

Result = Number of transmission x Length of transmission

*Average data of 5 tests.

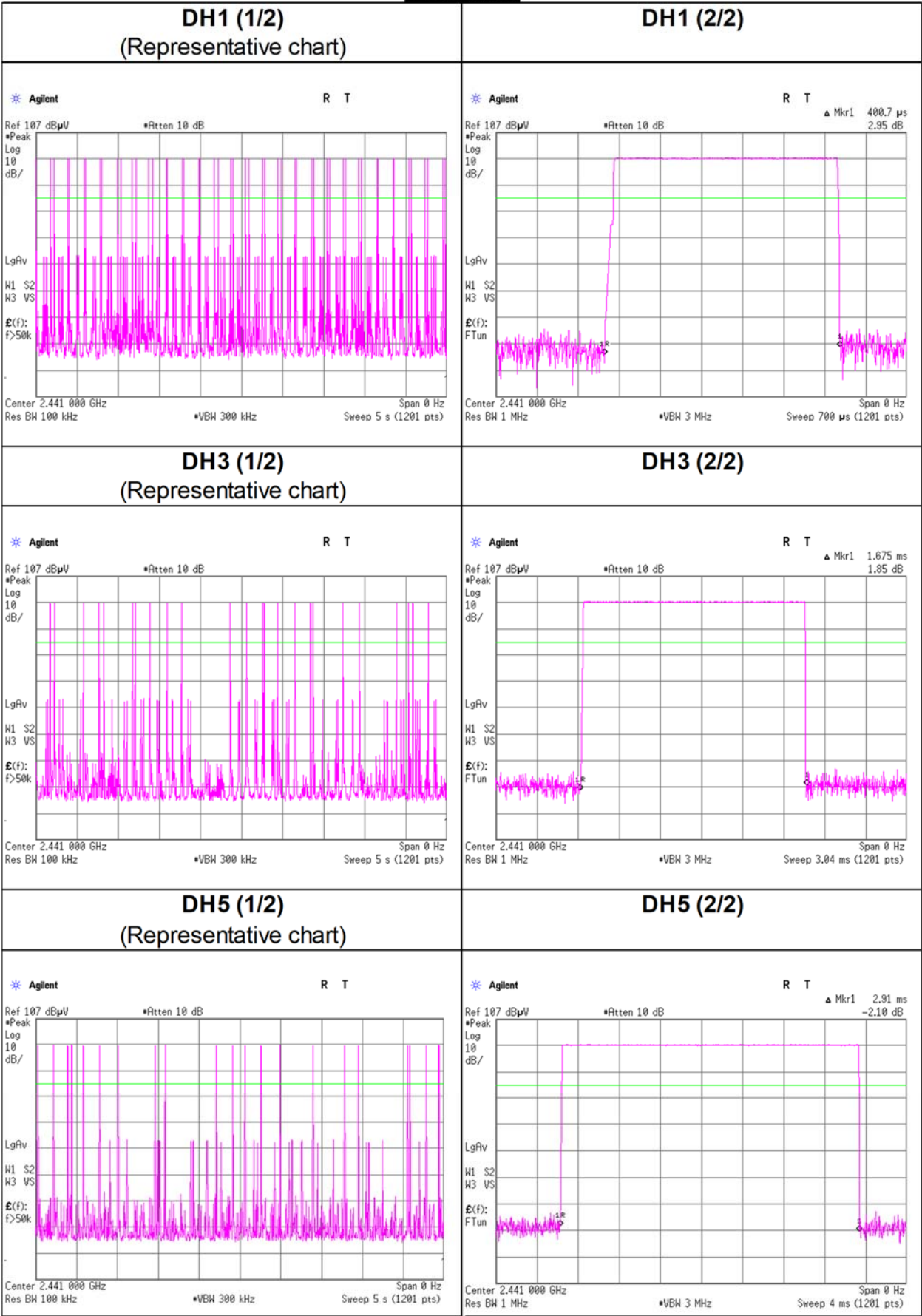
Mode	Sampling [times]					Average [times]
	1	2	3	4	5	
DH1	52	51	51	51	50	51
DH3	24	26	23	26	27	25.2
DH5	21	21	21	20	20	20.6
3DH1	51	50	51	51	51	50.8
3DH3	24	24	27	27	25	25.4
3DH5	20	20	20	20	21	20.2

Sample Calculation

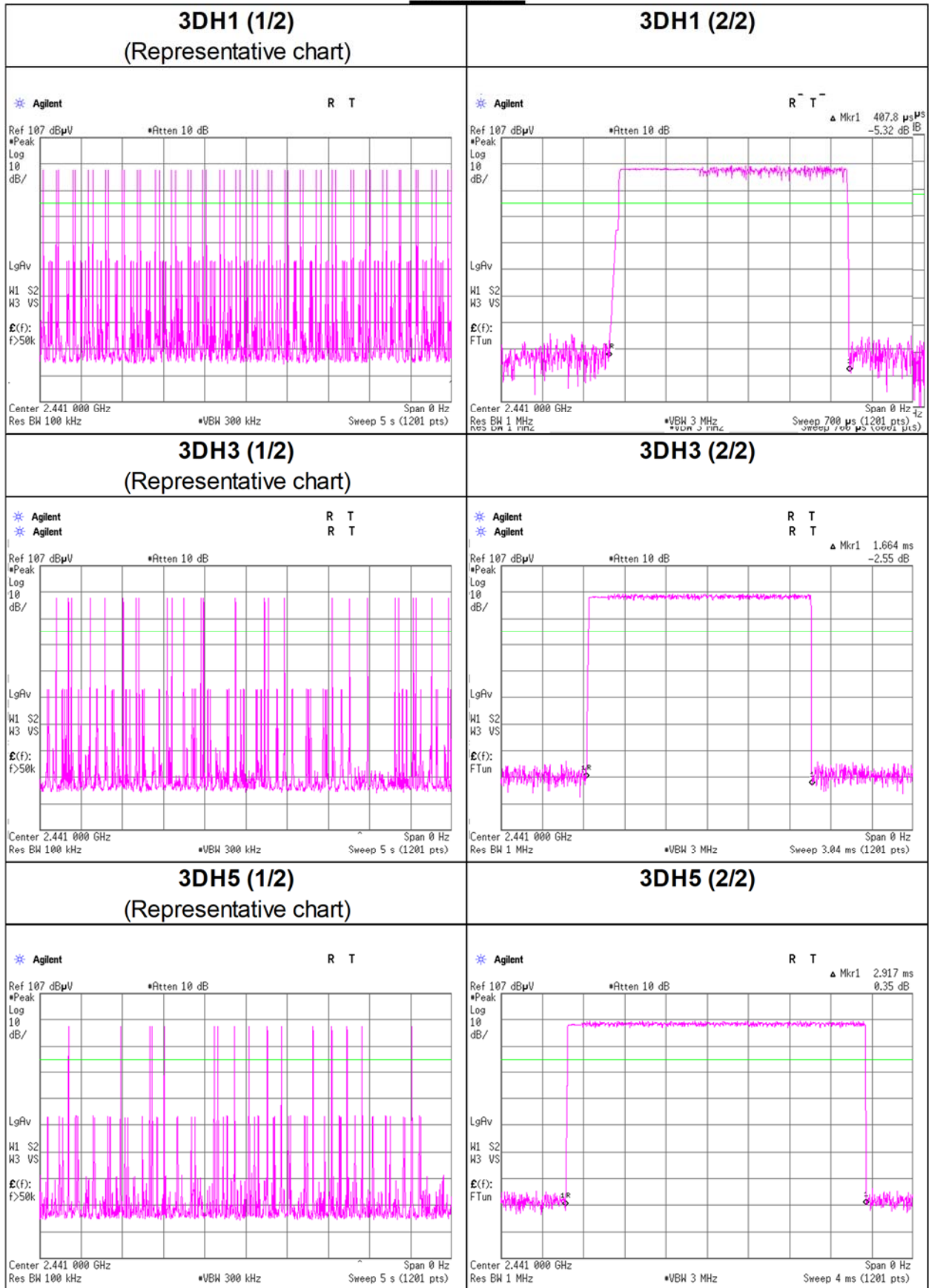
Average = Summation (Sampling 1 to 5) / 5

This device complies with the Bluetooth protocol for FHSS operation, employing a pseudo random channel selection and hopping rate to ensure that the occupancy time in $N \times 0.4$ s, where N is the number of channels being used in the hopping sequence ($20 \leq N \leq 79$), is always less than 0.4 s regardless of packet size. This is confirmed in the test report for $N = 79$.

Dwell time



Dwell time



Maximum Peak Output Power

Test place Shonan EMC Lab. No.5 Shielded Room
Date January 17, 2025
Temperature / Humidity 21 deg. C / 30 % RH
Engineer Miku Ikudome
Mode Tx, Hopping Off

Maximum peak output power

Mode	Freq. [MHz]	Reading [dBm]	Cable Loss [dB]	Atten. Loss [dB]	Conducted Power					e.i.r.p. for RSS-247					
					Result		Limit		Margin [dB]	Antenna Gain [dBi]	Result		Limit		Margin [dB]
					[dBm]	[mW]	[dBm]	[mW]			[dBm]	[mW]	[dBm]	[mW]	
DH5	2402	-9.14	2.25	9.63	2.74	1.88	20.97	125	18.23	-4.90	-2.16	0.61	36.02	4000	38.18
DH5	2441	-9.07	2.26	9.64	2.83	1.92	20.97	125	18.14	-4.90	-2.07	0.62	36.02	4000	38.09
DH5	2480	-9.78	2.27	9.64	2.13	1.63	20.97	125	18.84	-4.90	-2.77	0.53	36.02	4000	38.79
2DH5	2402	-9.99	2.25	9.63	1.89	1.55	20.97	125	19.08	-4.90	-3.01	0.50	36.02	4000	39.03
2DH5	2441	-9.72	2.26	9.64	2.18	1.65	20.97	125	18.79	-4.90	-2.72	0.53	36.02	4000	38.74
2DH5	2480	-10.68	2.27	9.64	1.23	1.33	20.97	125	19.74	-4.90	-3.67	0.43	36.02	4000	39.69
3DH5	2402	-9.57	2.25	9.63	2.31	1.70	20.97	125	18.66	-4.90	-2.59	0.55	36.02	4000	38.61
3DH5	2441	-9.44	2.26	9.64	2.46	1.76	20.97	125	18.51	-4.90	-2.44	0.57	36.02	4000	38.46
3DH5	2480	-10.26	2.27	9.64	1.65	1.46	20.97	125	19.32	-4.90	-3.25	0.47	36.02	4000	39.27

Sample Calculation:

Result = Reading + Cable Loss (including the cable(s) customer supplied) + Attenuator Loss

e.i.r.p. Result = Conducted Power Result + Antenna Gain

*The equipment and cables were not used for factor 0 dB of the data sheets.

Test was not performed at AFH mode, because the decrease of number of channel (min: 20 ch) at AFH mode does not influence on the output power and bandwidth of the EUT.
As this device had AFH mode and frequency separation could not meet the requirement of over 20 dB BW without 2/3 relaxation, 125 mW power limit was applied to it.

Average power (Reference data for RF Exposure / SAR testing)

Mode	Freq. [MHz]	Reading [dBm]	Cable Loss [dB]	Atten. Loss [dB]	Result (Time average)		Duty factor [dB]	Result (Burst power average)	
					[dBm]	[mW]		[dBm]	[mW]
					[dBm]	[mW]	[dB]	[dBm]	[mW]
DH5	2402	-10.67	2.25	9.63	1.21	1.32	1.11	2.32	1.71
DH5	2441	-10.50	2.26	9.64	1.40	1.38	1.11	2.51	1.78
DH5	2480	-11.33	2.27	9.64	0.58	1.14	1.11	1.69	1.48
2DH5	2402	-13.78	2.25	9.63	-1.90	0.65	1.10	-0.80	0.83
2DH5	2441	-13.06	2.26	9.64	-1.16	0.77	1.10	-0.06	0.99
2DH5	2480	-14.62	2.27	9.64	-2.71	0.54	1.10	-1.61	0.69
3DH5	2402	-13.75	2.25	9.63	-1.87	0.65	1.10	-0.77	0.84
3DH5	2441	-13.00	2.26	9.64	-1.10	0.78	1.10	0.00	1.00
3DH5	2480	-14.62	2.27	9.64	-2.71	0.54	1.10	-1.61	0.69

Sample Calculation:

Result (Time average) = Reading + Cable Loss (including the cable(s) customer supplied) + Attenuator Loss

Result (Burst power average) = Result (Time average) + Duty factor

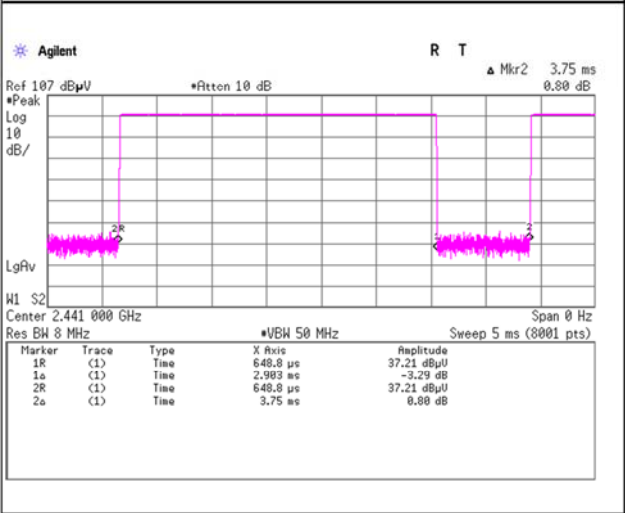
*The equipment and cables were not used for factor 0 dB of the data sheets.

Burst Rate Confirmation

Test place Shonan EMC Lab. No.5 Shielded Room
Date January 19, 2025
Temperature / Humidity 17 deg. C / 31 % RH
Engineer Yohsuke Matsuzawa
Mode Tx, Hopping Off

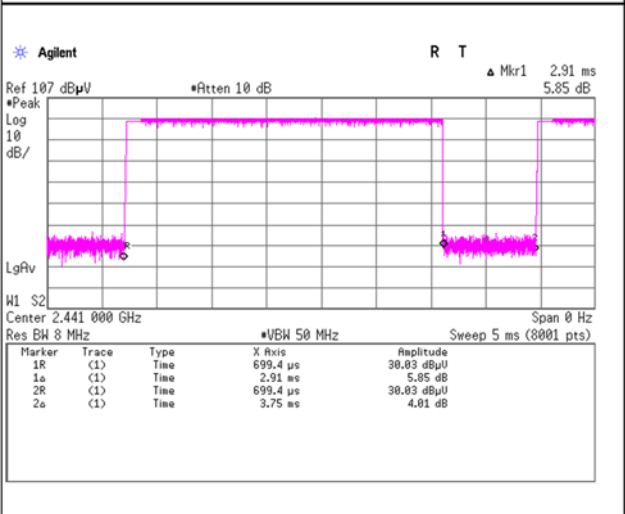
DH5

Tx on / (Tx on + Tx off) = **0.774**
Tx on / (Tx on + Tx off) * 100 = **77.4 %**
Duty factor = 10 * log (3.75 / 2.903) = **1.11 dB**
VBW: 1 / on time = 344.46 Hz < **500.00 Hz**



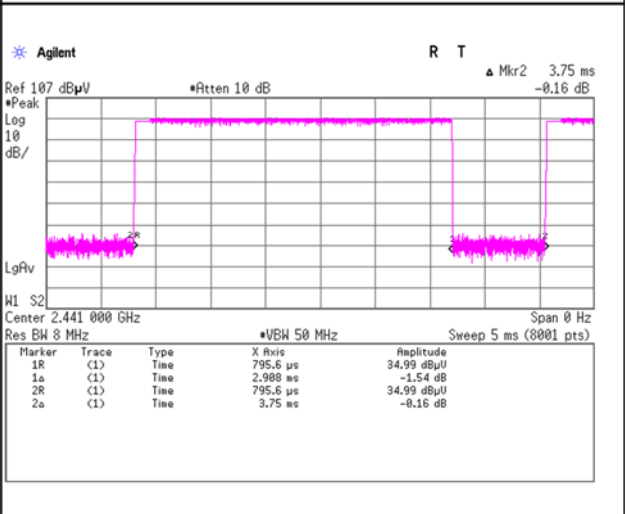
2DH5

Tx on / (Tx on + Tx off) = **0.776**
Tx on / (Tx on + Tx off) * 100 = **77.6 %**
Duty factor = 10 * log (3.75 / 2.91) = **1.10 dB**
VBW: 1 / on time = 343.64 Hz < **500.00 Hz**



3DH5

Tx on / (Tx on + Tx off) = **0.775**
Tx on / (Tx on + Tx off) * 100 = **77.5 %**
Duty factor = 10 * log (3.75 / 2.908) = **1.10 dB**
VBW: 1 / on time = 343.86 Hz < **500.00 Hz**



Radiated Spurious Emission

Test place	Shonan EMC Lab.		
Semi Anechoic Chamber	WAC1	WAC1	WAC1
Date	January 21, 2025	January 25, 2025	January 27, 2025
Temperature / Humidity	21 deg. C / 42 % RH	20 deg. C / 33 % RH	20 deg. C / 28 % RH
Engineer	Kouki Yamada (1 GHz to 10 GHz)	Masahide Ozaki (10 GHz to 18 GHz)	Takayuki Kobayashi (18 GHz to 26.5 GHz)
Mode	Tx, Hopping Off, DH5 2402 MHz		

(* PK: Peak, AV: Average, QP: Quasi-Peak)

Polarity	Frequency [MHz]	Detector	Reading [dBuV]	Ant.Fac. [dB/m]	Loss [dB]	Gain [dB]	Distance Fac. [dB]	Result [dBuV/m]	Limit [dBuV/m]	Margin [dB]	Height [cm]	Angle [deg.]	Remark
Hori.	2390.000	PK	46.99	27.85	-28.00	-	2.26	49.10	73.9	24.8	136	29	-
Hori.	4804.000	PK	46.71	31.97	-35.33	-	2.26	45.61	73.9	28.2	150	0	Floor Noise
Hori.	7206.000	PK	46.94	36.23	-34.02	-	2.26	51.41	73.9	22.4	150	0	Floor Noise
Hori.	9608.000	PK	45.91	37.93	-31.46	-	2.26	54.64	73.9	19.2	150	0	Floor Noise
Hori.	2390.000	AV	33.14	27.85	-28.00	-	2.26	35.25	53.9	18.6	136	29	VBW:500 Hz
Hori.	4804.000	AV	32.60	31.97	-35.33	-	2.26	31.50	53.9	22.4	150	0	VBW:500 Hz, Floor Noise
Hori.	7206.000	AV	32.71	36.23	-34.02	-	2.26	37.18	53.9	16.7	150	0	VBW:500 Hz, Floor Noise
Hori.	9608.000	AV	31.63	37.93	-31.46	-	2.26	40.36	53.9	13.5	150	0	VBW:500 Hz, Floor Noise
Vert.	2390.000	PK	47.24	27.85	-28.00	-	2.26	49.35	73.9	24.5	209	207	-
Vert.	4804.000	PK	46.61	31.97	-35.33	-	2.26	45.51	73.9	28.3	150	0	Floor Noise
Vert.	7206.000	PK	47.14	36.23	-34.02	-	2.26	51.61	73.9	22.2	150	0	Floor Noise
Vert.	9608.000	PK	45.65	37.93	-31.46	-	2.26	54.38	73.9	19.5	150	0	Floor Noise
Vert.	2390.000	AV	33.07	27.85	-28.00	-	2.26	35.18	53.9	18.7	209	207	VBW:500 Hz
Vert.	4804.000	AV	32.49	31.97	-35.33	-	2.26	31.39	53.9	22.5	150	0	VBW:500 Hz, Floor Noise
Vert.	7206.000	AV	32.84	36.23	-34.02	-	2.26	37.31	53.9	16.5	150	0	VBW:500 Hz, Floor Noise
Vert.	9608.000	AV	31.34	37.93	-31.46	-	2.26	40.07	53.9	13.8	150	0	VBW:500 Hz, Floor Noise

Result = Reading + Ant.Fac. + Loss (Cable + (Atten or Filter)(below 18 GHz) - Gain(Amp) (1 GHz to 18 GHz)) - Gain(Amp) (only below 1 GHz & above 18 GHz) + Distance Fac.

*Other frequency noises omitted in this report were not seen or have enough margin (more than 20 dB).

Distance Fac. : 1 GHz to 10 GHz : $20\log(3.89[\text{m}]/3.0[\text{m}]) = 2.26[\text{dB}]$

10 GHz to 40 GHz : $20\log(1.00[\text{m}]/3.0[\text{m}]) = -9.54[\text{dB}]$

20 dBc Data Sheet

(RBW 100 kHz, VBW 300 kHz)

Polarity	Frequency [MHz]	Detector	Reading [dBuV]	Ant.Fac. [dB/m]	Loss [dB]	Gain [dB]	Distance Fac. [dB]	Result [dBuV/m]	Limit [dBuV/m]	Margin [dB]	Remark
Hori.	2402.000	PK	90.60	27.89	-27.99	-	2.26	92.76	-	-	Carrier
Hori.	2400.000	PK	40.27	27.89	-27.99	-	2.26	42.43	72.7	30.2	-
Vert.	2402.000	PK	89.73	27.89	-27.99	-	2.26	91.89	-	-	Carrier
Vert.	2400.000	PK	38.91	27.89	-27.99	-	2.26	41.07	71.8	30.7	-

Result = Reading + Ant.Fac. + Loss (Cable + (Atten or Filter)(below 18 GHz) - Gain(Amp) (1 GHz to 18 GHz)) - Gain(Amp) (only below 1 GHz & above 18 GHz) + Distance Fac.

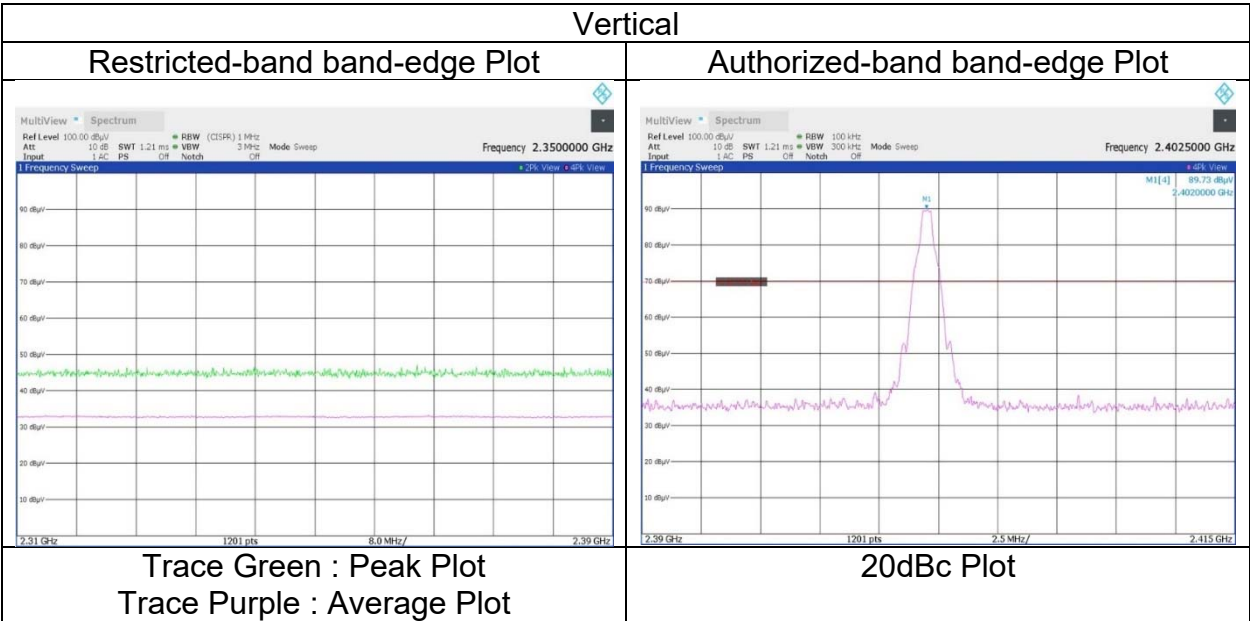
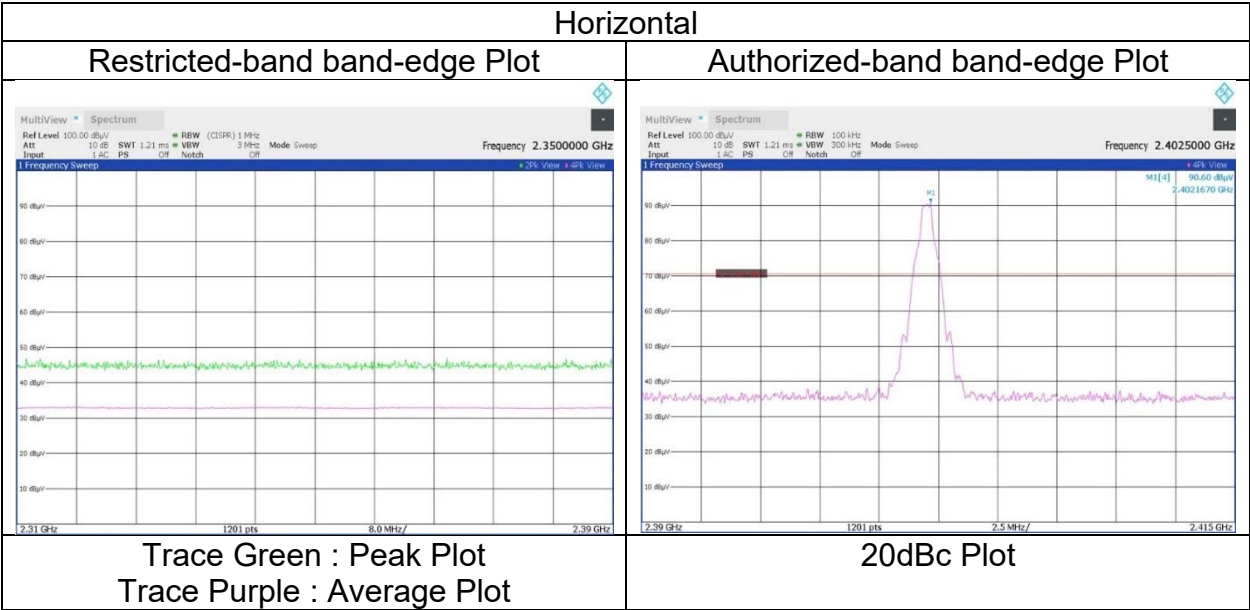
Distance Fac. : 1 GHz to 10 GHz : $20\log(3.89[\text{m}]/3.0[\text{m}]) = 2.26[\text{dB}]$

10 GHz to 40 GHz : $20\log(1.00[\text{m}]/3.0[\text{m}]) = -9.54[\text{dB}]$

Radiated Spurious Emission
(Reference Plot for band-edge)

Test place
Semi Anechoic Chamber
Date
Temperature / Humidity
Engineer
Mode

Shonan EMC Lab.
WAC1
January 21, 2025
21 deg. C / 42 % RH
Kouki Yamada
Tx, Hopping Off, DH5 2402 MHz



* The measurement was conducted for a sufficiently long enough time to detect any possible spurious emissions.
Final result of restricted band edge and authorized band edge were shown in tabular data.

Radiated Spurious Emission

Test place	Shonan EMC Lab.			
Semi Anechoic Chamber	WAC1	WAC1	WAC1	WAC1
Date	January 28, 2025	January 21, 2025	January 25, 2025	January 27, 2025
Temperature / Humidity	21 deg. C / 28 % RH	21 deg. C / 42 % RH	20 deg. C / 33 % RH	20 deg. C / 28 % RH
Engineer	Makoto Hosaka (30 MHz to 1 GHz)	Kouki Yamada (1 GHz to 10 GHz)	Masahide Ozaki (10 GHz to 18 GHz)	Takayuki Kobayashi (18 GHz to 26.5 GHz)
Mode	Tx, Hopping Off, DH5 2441 MHz			

(* PK: Peak, AV: Average, QP: Quasi-Peak)

Polarity	Frequency [MHz]	Detector	Reading [dBuV]	Ant.Fac. [dB/m]	Loss [dB]	Gain [dB]	Distance Fac. [dB]	Result [dBuV/m]	Limit [dBuV/m]	Margin [dB]	Height [cm]	Angle [deg.]	Remark
Hori.	128.003	QP	35.90	11.12	6.77	28.35	0.00	25.44	43.5	18.0	279	271	-
Hori.	294.913	QP	43.60	13.59	7.48	27.76	0.00	36.91	46.0	9.0	100	42	-
Hori.	393.216	QP	44.20	15.52	7.77	28.37	0.00	39.12	46.0	6.8	100	262	-
Hori.	400.003	QP	43.60	15.74	7.80	28.42	0.00	38.72	46.0	7.2	100	259	-
Hori.	420.007	QP	40.80	16.00	7.85	28.53	0.00	36.12	46.0	9.8	100	12	-
Hori.	442.371	QP	41.80	16.31	7.91	28.65	0.00	37.37	46.0	8.6	100	267	-
Hori.	933.008	QP	33.30	21.87	8.89	28.14	0.00	35.92	46.0	10.0	106	292	-
Hori.	4882.000	PK	47.05	32.34	-35.41	-	2.26	46.24	73.9	27.6	150	0	Floor Noise
Hori.	7323.000	PK	47.02	36.63	-33.85	-	2.26	52.06	73.9	21.8	150	0	Floor Noise
Hori.	9764.000	PK	45.96	37.93	-31.32	-	2.26	54.83	73.9	19.0	150	0	Floor Noise
Hori.	4882.000	AV	32.90	32.34	-35.41	-	2.26	32.09	53.9	21.8	150	0	VBW:500 Hz, Floor Noise
Hori.	7323.000	AV	33.30	36.63	-33.85	-	2.26	38.34	53.9	15.5	150	0	VBW:500 Hz, Floor Noise
Hori.	9764.000	AV	31.62	37.93	-31.32	-	2.26	40.49	53.9	13.4	150	0	VBW:500 Hz, Floor Noise
Vert.	117.654	QP	38.00	10.58	6.78	28.40	0.00	26.96	43.5	16.5	100	280	-
Vert.	420.007	QP	39.80	16.00	7.85	28.53	0.00	35.12	46.0	10.8	100	101	-
Vert.	4882.000	PK	47.12	32.34	-35.41	-	2.26	46.31	73.9	27.5	150	0	Floor Noise
Vert.	7323.000	PK	46.64	36.63	-33.85	-	2.26	51.68	73.9	22.2	150	0	Floor Noise
Vert.	9764.000	PK	45.86	37.93	-31.32	-	2.26	54.73	73.9	19.1	150	0	Floor Noise
Vert.	4882.000	AV	32.98	32.34	-35.41	-	2.26	32.17	53.9	21.7	150	0	VBW:500 Hz, Floor Noise
Vert.	7323.000	AV	32.94	36.63	-33.85	-	2.26	37.98	53.9	15.9	150	0	VBW:500 Hz, Floor Noise
Vert.	9764.000	AV	31.61	37.93	-31.32	-	2.26	40.48	53.9	13.4	150	0	VBW:500 Hz, Floor Noise

Result = Reading + Ant.Fac. + Loss (Cable + (Atten or Filter)(below 18 GHz) - Gain(Amp) (1 GHz to 18 GHz)) - Gain(Amp) (only below 1 GHz & above 18 GHz) + Distance Fac.

*Other frequency noises omitted in this report were not seen or have enough margin (more than 20 dB).

Distance Fac.: 1 GHz to 10 GHz : $20\log(3.89[m]/3.0[m]) = 2.26[dB]$

10 GHz to 40 GHz : $20\log(1.00[m]/3.0[m]) = -9.54[dB]$

Radiated Spurious Emission

Test place	Shonan EMC Lab.		
Semi Anechoic Chamber	WAC1	WAC1	WAC1
Date	January 21, 2025	January 25, 2025	January 27, 2025
Temperature / Humidity	21 deg. C / 42 % RH	20 deg. C / 33 % RH	20 deg. C / 28 % RH
Engineer	Kouki Yamada (1 GHz to 10 GHz)	Masahide Ozaki (10 GHz to 18 GHz)	Takayuki Kobayashi (18 GHz to 26.5 GHz)
Mode	Tx, Hopping Off, DH5 2480 MHz		

(* PK: Peak, AV: Average, QP: Quasi-Peak)

Polarity	Frequency	Detector	Reading	Ant.Fac.	Loss	Gain	Distance	Result	Limit	Margin	Height	Angle	Remark
	[MHz]		[dBuV]	[dB/m]	[dB]	[dB]	Fac. [dB]	[dBuV/m]	[dBuV/m]	[dB]	[cm]	[deg.]	
Hori.	2483.500	PK	46.95	27.96	-27.94	-	2.26	49.23	73.9	24.6	136	309	-
Hori.	4960.000	PK	47.89	32.62	-35.50	-	2.26	47.27	73.9	26.6	213	220	-
Hori.	7440.000	PK	47.53	36.69	-33.66	-	2.26	52.82	73.9	21.0	150	0	Floor Noise
Hori.	9920.000	PK	45.31	37.93	-31.18	-	2.26	54.32	73.9	19.5	150	0	Floor Noise
Hori.	2483.500	AV	33.29	27.96	-27.94	-	2.26	35.57	53.9	18.3	136	309	VBW:500 Hz
Hori.	4960.000	AV	35.93	32.62	-35.50	-	2.26	35.31	53.9	18.5	213	220	VBW:500 Hz
Hori.	7440.000	AV	32.80	36.69	-33.66	-	2.26	38.09	53.9	15.8	150	0	VBW:500 Hz, Floor Noise
Hori.	9920.000	AV	31.06	37.93	-31.18	-	2.26	40.07	53.9	13.8	150	0	VBW:500 Hz, Floor Noise
Vert.	2483.500	PK	47.65	27.96	-27.94	-	2.26	49.93	73.9	23.9	399	219	-
Vert.	4960.000	PK	47.58	32.62	-35.50	-	2.26	46.96	73.9	26.9	153	53	-
Vert.	7440.000	PK	46.92	36.69	-33.66	-	2.26	52.21	73.9	21.6	150	0	Floor Noise
Vert.	9920.000	PK	46.17	37.93	-31.18	-	2.26	55.18	73.9	18.7	150	0	Floor Noise
Vert.	2483.500	AV	33.28	27.96	-27.94	-	2.26	35.56	53.9	18.3	399	219	VBW:500 Hz
Vert.	4960.000	AV	36.24	32.62	-35.50	-	2.26	35.62	53.9	18.2	153	53	VBW:500 Hz
Vert.	7440.000	AV	32.78	36.69	-33.66	-	2.26	38.07	53.9	15.8	150	0	VBW:500 Hz, Floor Noise
Vert.	9920.000	AV	31.25	37.93	-31.18	-	2.26	40.26	53.9	13.6	150	0	VBW:500 Hz, Floor Noise

Result = Reading + Ant.Fac. + Loss (Cable + (Atten or Filter)(below 18 GHz) - Gain(Amp) (1 GHz to 18 GHz)) - Gain(Amp) (only below 1 GHz & above 18 GHz) + Distance Fac.

*Other frequency noises omitted in this report were not seen or have enough margin (more than 20 dB).

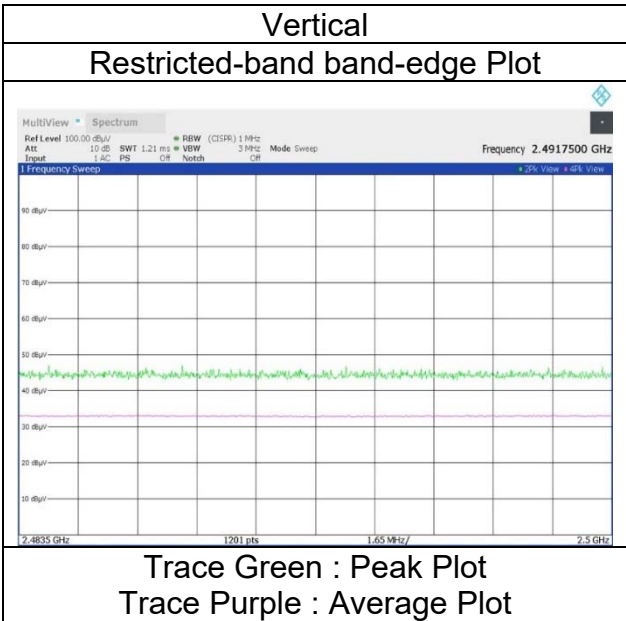
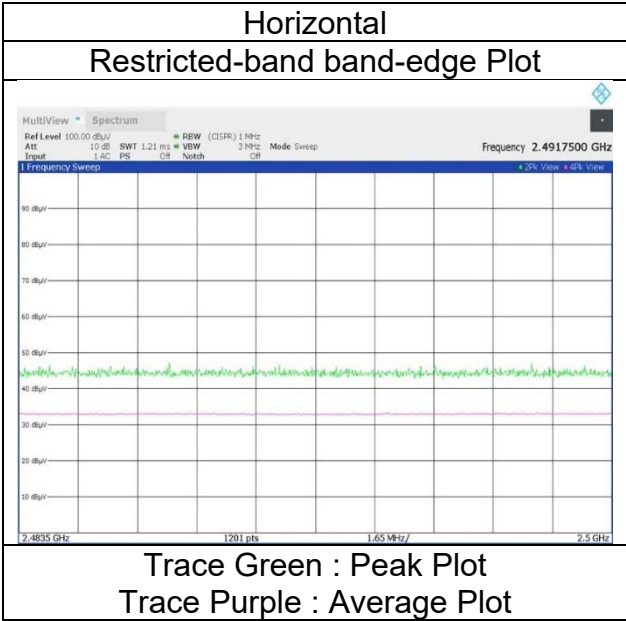
Distance Fac. : 1 GHz to 10 GHz : $20\log(3.89[m]/3.0[m]) = 2.26 [dB]$

10 GHz to 40 GHz : $20\log(1.00[m]/3.0[m]) = -9.54 [dB]$

Radiated Spurious Emission
(Reference Plot for band-edge)

Test place
Semi Anechoic Chamber
Date
Temperature / Humidity
Engineer
Mode

Shonan EMC Lab.
WAC1
January 21, 2025
21 deg. C / 42 % RH
Kouki Yamada
Tx, Hopping Off, DH5 2480 MHz



* The measurement was conducted for a sufficiently long enough time to detect any possible spurious emissions.
Final result of restricted band edge was shown in tabular data.

Radiated Spurious Emission

Test place	Shonan EMC Lab.		
Semi Anechoic Chamber	WAC1	WAC1	WAC1
Date	January 21, 2025	January 25, 2025	January 27, 2025
Temperature / Humidity	21 deg. C / 42 % RH	20 deg. C / 33 % RH	20 deg. C / 28 % RH
Engineer	Kouki Yamada	Masahide Ozaki	Takayuki Kobayashi
	(1 GHz to 10 GHz)	(10 GHz to 18 GHz)	(18 GHz to 26.5 GHz)
Mode	Tx, Hopping Off, 3DH5 2402 MHz		

(* PK: Peak, AV: Average, QP: Quasi-Peak)

Polarity	Frequency	Detector	Reading	Ant.Fac.	Loss	Gain	Distance	Result	Limit	Margin	Height	Angle	Remark
	[MHz]		[dBuV]	[dB/m]	[dB]	[dB]	Fac. [dB]	[dBuV/m]	[dBuV/m]	[dB]	[cm]	[deg.]	
Hori.	2390.000	PK	47.13	27.85	-28.00	-	2.26	49.24	73.9	24.6	154	32	-
Hori.	4804.000	PK	46.52	31.97	-35.33	-	2.26	45.42	73.9	28.4	150	0	Floor Noise
Hori.	7206.000	PK	46.47	36.23	-34.02	-	2.26	50.94	73.9	22.9	150	0	Floor Noise
Hori.	9608.000	PK	45.65	37.93	-31.46	-	2.26	54.38	73.9	19.5	150	0	Floor Noise
Hori.	2390.000	AV	33.21	27.85	-28.00	-	2.26	35.32	53.9	18.5	154	32	VBW:500 Hz
Hori.	4804.000	AV	32.37	31.97	-35.33	-	2.26	31.27	53.9	22.6	150	0	VBW:500 Hz, Floor Noise
Hori.	7206.000	AV	32.81	36.23	-34.02	-	2.26	37.28	53.9	16.6	150	0	VBW:500 Hz, Floor Noise
Hori.	9608.000	AV	31.56	37.93	-31.46	-	2.26	40.29	53.9	13.6	150	0	VBW:500 Hz, Floor Noise
Vert.	2390.000	PK	47.64	27.85	-28.00	-	2.26	49.75	73.9	24.1	135	47	-
Vert.	4804.000	PK	46.94	31.97	-35.33	-	2.26	45.84	73.9	28.0	150	0	Floor Noise
Vert.	7206.000	PK	47.52	36.23	-34.02	-	2.26	51.99	73.9	21.9	150	0	Floor Noise
Vert.	9608.000	PK	46.36	37.93	-31.46	-	2.26	55.09	73.9	18.8	150	0	Floor Noise
Vert.	2390.000	AV	33.06	27.85	-28.00	-	2.26	35.17	53.9	18.7	135	47	VBW:500 Hz
Vert.	4804.000	AV	32.89	31.97	-35.33	-	2.26	31.79	53.9	22.1	150	0	VBW:500 Hz, Floor Noise
Vert.	7206.000	AV	33.00	36.23	-34.02	-	2.26	37.47	53.9	16.4	150	0	VBW:500 Hz, Floor Noise
Vert.	9608.000	AV	31.97	37.93	-31.46	-	2.26	40.70	53.9	13.2	150	0	VBW:500 Hz, Floor Noise

Result = Reading + Ant.Fac. + Loss (Cable + (Atten or Filter)(below 18 GHz) - Gain(Amp) (1 GHz to 18 GHz)) - Gain(Amp) (only below 1 GHz & above 18 GHz) + Distance Fac.

*Other frequency noises omitted in this report were not seen or have enough margin (more than 20 dB).

Distance Fac. : 1 GHz to 10 GHz : $20\log(3.89[\text{m}]/3.0[\text{m}]) = 2.26[\text{dB}]$

10 GHz to 40 GHz : $20\log(1.00[\text{m}]/3.0[\text{m}]) = -9.54[\text{dB}]$

20 dBc Data Sheet

(RBW 100 kHz, VBW 300 kHz)

Polarity	Frequency	Detector	Reading	Ant.Fac.	Loss	Gain	Distance	Result	Limit	Margin	Remark
	[MHz]		[dBuV]	[dB/m]	[dB]	[dB]	Fac. [dB]	[dBuV/m]	[dBuV/m]	[dB]	
Hori.	2402.000	PK	86.92	27.89	-27.99	-	2.26	89.08	-	-	Carrier
Hori.	2400.000	PK	39.43	27.89	-27.99	-	2.26	41.59	69.0	27.4	-
Vert.	2402.000	PK	84.80	27.89	-27.99	-	2.26	86.96	-	-	Carrier
Vert.	2400.000	PK	39.17	27.89	-27.99	-	2.26	41.33	66.9	25.5	-

Result = Reading + Ant.Fac. + Loss (Cable + (Atten or Filter)(below 18 GHz) - Gain(Amp) (1 GHz to 18 GHz)) - Gain(Amp) (only below 1 GHz & above 18 GHz) + Distance Fac.

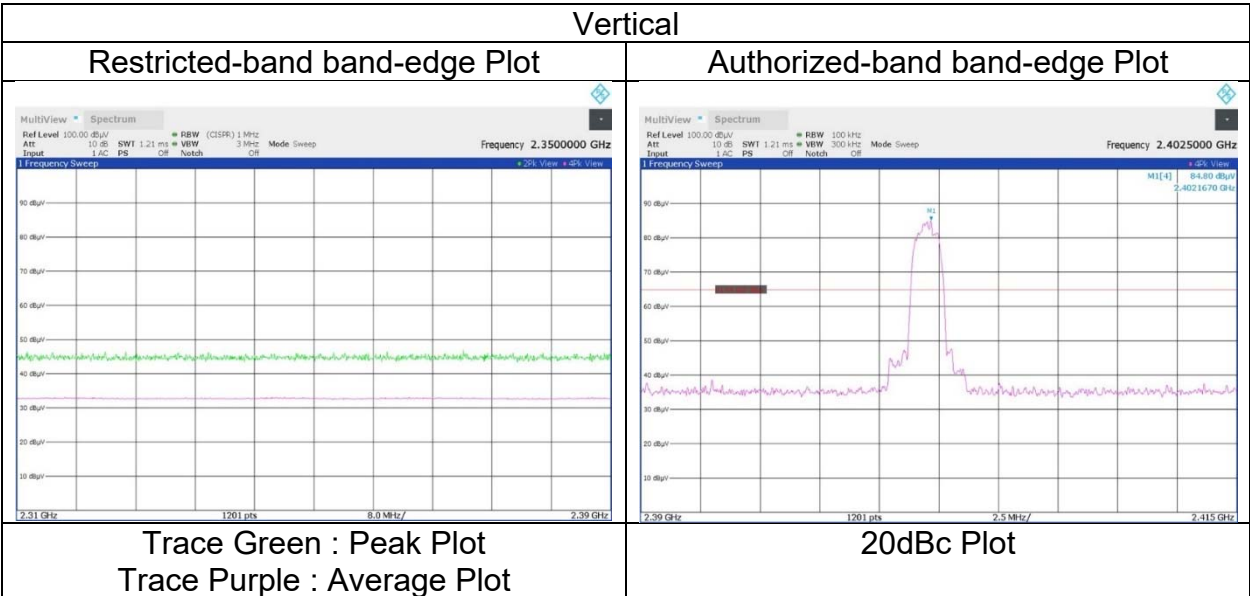
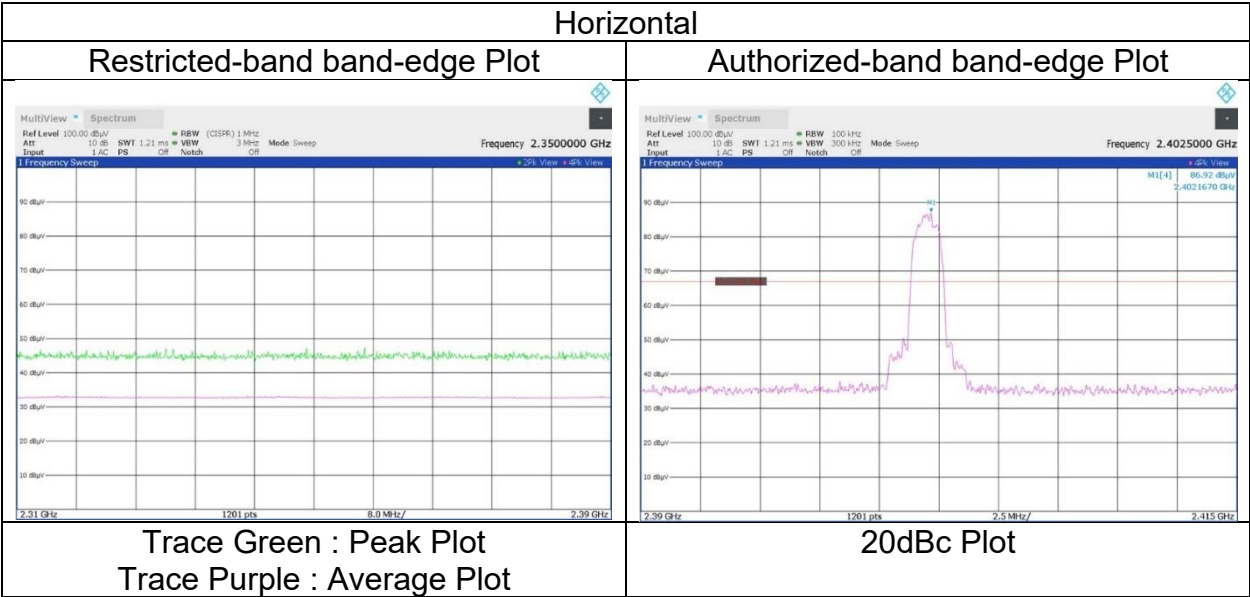
Distance Fac. : 1 GHz to 10 GHz : $20\log(3.89[\text{m}]/3.0[\text{m}]) = 2.26[\text{dB}]$

10 GHz to 40 GHz : $20\log(1.00[\text{m}]/3.0[\text{m}]) = -9.54[\text{dB}]$

Radiated Spurious Emission
(Reference Plot for band-edge)

Test place
Semi Anechoic Chamber
Date
Temperature / Humidity
Engineer
Mode

Shonan EMC Lab.
WAC1
January 21, 2025
21 deg. C / 42 % RH
Kouki Yamada
Tx, Hopping Off, 3DH5 2402 MHz



* The measurement was conducted for a sufficiently long enough time to detect any possible spurious emissions.
Final result of restricted band edge and authorized band edge were shown in tabular data.

Radiated Spurious Emission

Test place	Shonan EMC Lab.		
Semi Anechoic Chamber	WAC1	WAC1	WAC1
Date	January 21, 2025	January 25, 2025	January 27, 2025
Temperature / Humidity	21 deg. C / 42 % RH	20 deg. C / 33 % RH	20 deg. C / 28 % RH
Engineer	Kouki Yamada (1 GHz to 10 GHz)	Masahide Ozaki (10 GHz to 18 GHz)	Takayuki Kobayashi (18 GHz to 26.5 GHz)
Mode	Tx, Hopping Off, 3DH5 2441 MHz		

(* PK: Peak, AV: Average, QP: Quasi-Peak)

Polarity	Frequency [MHz]	Detector	Reading [dBuV]	Ant.Fac. [dB/m]	Loss [dB]	Gain [dB]	Distance Fac. [dB]	Result [dBuV/m]	Limit [dBuV/m]	Margin [dB]	Height [cm]	Angle [deg.]	Remark
Hori.	4882.000	PK	47.67	32.34	-35.41	-	2.26	46.86	73.9	27.0	150	0	Floor Noise
Hori.	7323.000	PK	46.51	36.63	-33.85	-	2.26	51.55	73.9	22.3	150	0	Floor Noise
Hori.	9764.000	PK	45.63	37.93	-31.32	-	2.26	54.50	73.9	19.4	150	0	Floor Noise
Hori.	4882.000	AV	32.85	32.34	-35.41	-	2.26	32.04	53.9	21.8	150	0	VBW:500 Hz, Floor Noise
Hori.	7323.000	AV	32.75	36.63	-33.85	-	2.26	37.79	53.9	16.1	150	0	VBW:500 Hz, Floor Noise
Hori.	9764.000	AV	31.37	37.93	-31.32	-	2.26	40.24	53.9	13.6	150	0	VBW:500 Hz, Floor Noise
Vert.	4882.000	PK	47.44	32.34	-35.41	-	2.26	46.63	73.9	27.2	150	0	Floor Noise
Vert.	7323.000	PK	46.54	36.63	-33.85	-	2.26	51.58	73.9	22.3	150	0	Floor Noise
Vert.	9764.000	PK	45.43	37.93	-31.32	-	2.26	54.30	73.9	19.6	150	0	Floor Noise
Vert.	4882.000	AV	32.82	32.34	-35.41	-	2.26	32.01	53.9	21.8	150	0	VBW:500 Hz, Floor Noise
Vert.	7323.000	AV	32.78	36.63	-33.85	-	2.26	37.82	53.9	16.0	150	0	VBW:500 Hz, Floor Noise
Vert.	9764.000	AV	31.40	37.93	-31.32	-	2.26	40.27	53.9	13.6	150	0	VBW:500 Hz, Floor Noise

Result = Reading + Ant.Fac. + Loss (Cable + (Atten or Filter)(below 18 GHz) - Gain(Amp) (1 GHz to 18 GHz)) - Gain(Amp) (only below 1 GHz & above 18 GHz) + Distance Fac.

*Other frequency noises omitted in this report were not seen or have enough margin (more than 20 dB).

Distance Fac. : 1 GHz to 10 GHz : $20\log(3.89[m]/3.0[m]) = 2.26 [dB]$

10 GHz to 40 GHz : $20\log(1.00[m]/3.0[m]) = -9.54 [dB]$

Radiated Spurious Emission

Test place	Shonan EMC Lab.		
Semi Anechoic Chamber	WAC1	WAC1	WAC1
Date	January 21, 2025	January 25, 2025	January 27, 2025
Temperature / Humidity	21 deg. C / 42 % RH	20 deg. C / 33 % RH	20 deg. C / 28 % RH
Engineer	Kouki Yamada (1 GHz to 10 GHz)	Masahide Ozaki (10 GHz to 18 GHz)	Takayuki Kobayashi (18 GHz to 26.5 GHz)
Mode	Tx, Hopping Off, 3DH5 2480 MHz		

(* PK: Peak, AV: Average, QP: Quasi-Peak)

Polarity	Frequency	Detector	Reading	Ant.Fac.	Loss	Gain	Distance	Result	Limit	Margin	Height	Angle	Remark
	[MHz]		[dBuV]	[dB/m]	[dB]	[dB]	Fac. [dB]	[dBuV/m]	[dBuV/m]	[dB]	[cm]	[deg.]	
Hori.	2483.500	PK	47.06	27.96	-27.94	-	2.26	49.34	73.9	24.5	224	306	-
Hori.	4960.000	PK	47.47	32.62	-35.50	-	2.26	46.85	73.9	27.0	150	0	Floor Noise
Hori.	7440.000	PK	46.74	36.69	-33.66	-	2.26	52.03	73.9	21.8	150	0	Floor Noise
Hori.	9920.000	PK	45.63	37.93	-31.18	-	2.26	54.64	73.9	19.2	150	0	Floor Noise
Hori.	2483.500	AV	33.27	27.96	-27.94	-	2.26	35.55	53.9	18.3	224	306	VBW:500 Hz
Hori.	4960.000	AV	32.96	32.62	-35.50	-	2.26	32.34	53.9	21.5	150	0	VBW:500 Hz, Floor Noise
Hori.	7440.000	AV	32.58	36.69	-33.66	-	2.26	37.87	53.9	16.0	150	0	VBW:500 Hz, Floor Noise
Hori.	9920.000	AV	31.06	37.93	-31.18	-	2.26	40.07	53.9	13.8	150	0	VBW:500 Hz, Floor Noise
Vert.	2483.500	PK	47.32	27.96	-27.94	-	2.26	49.60	73.9	24.3	223	214	-
Vert.	4960.000	PK	46.89	32.62	-35.50	-	2.26	46.27	73.9	27.6	150	0	Floor Noise
Vert.	7440.000	PK	46.77	36.69	-33.66	-	2.26	52.06	73.9	21.8	150	0	Floor Noise
Vert.	9920.000	PK	45.70	37.93	-31.18	-	2.26	54.71	73.9	19.1	150	0	Floor Noise
Vert.	2483.500	AV	33.30	27.96	-27.94	-	2.26	35.58	53.9	18.3	223	214	VBW:500 Hz
Vert.	4960.000	AV	32.97	32.62	-35.50	-	2.26	32.35	53.9	21.5	150	0	VBW:500 Hz, Floor Noise
Vert.	7440.000	AV	32.53	36.69	-33.66	-	2.26	37.82	53.9	16.0	150	0	VBW:500 Hz, Floor Noise
Vert.	9920.000	AV	31.12	37.93	-31.18	-	2.26	40.13	53.9	13.7	150	0	VBW:500 Hz, Floor Noise

Result = Reading + Ant.Fac. + Loss (Cable + (Atten or Filter)(below 18 GHz) - Gain(Amp) (1 GHz to 18 GHz)) - Gain(Amp) (only below 1 GHz & above 18 GHz) + Distance Fac.

*Other frequency noises omitted in this report were not seen or have enough margin (more than 20 dB).

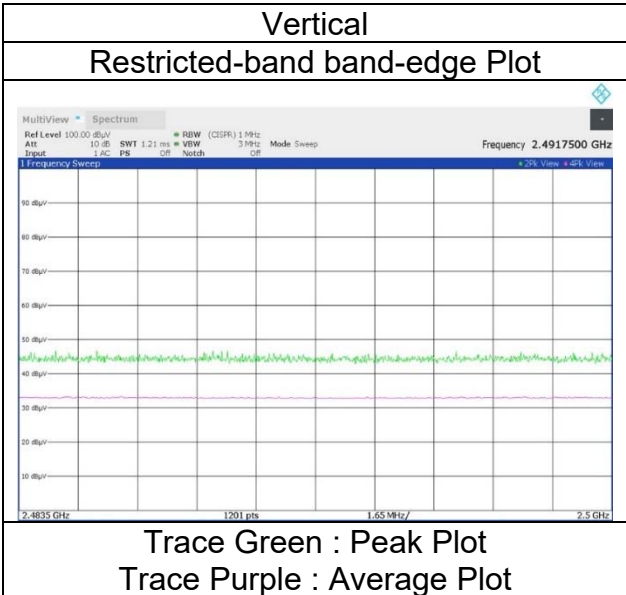
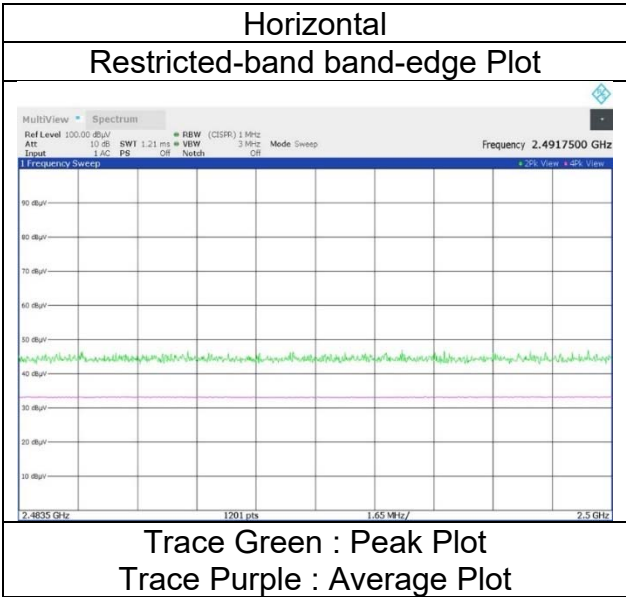
Distance Fac. : 1 GHz to 10 GHz : $20\log(3.89[m]/3.0[m]) = 2.26 [dB]$

10 GHz to 40 GHz : $20\log(1.00[m]/3.0[m]) = -9.54 [dB]$

**Radiated Spurious Emission
(Reference Plot for band-edge)**

Test place
Semi Anechoic Chamber
Date
Temperature / Humidity
Engineer
Mode

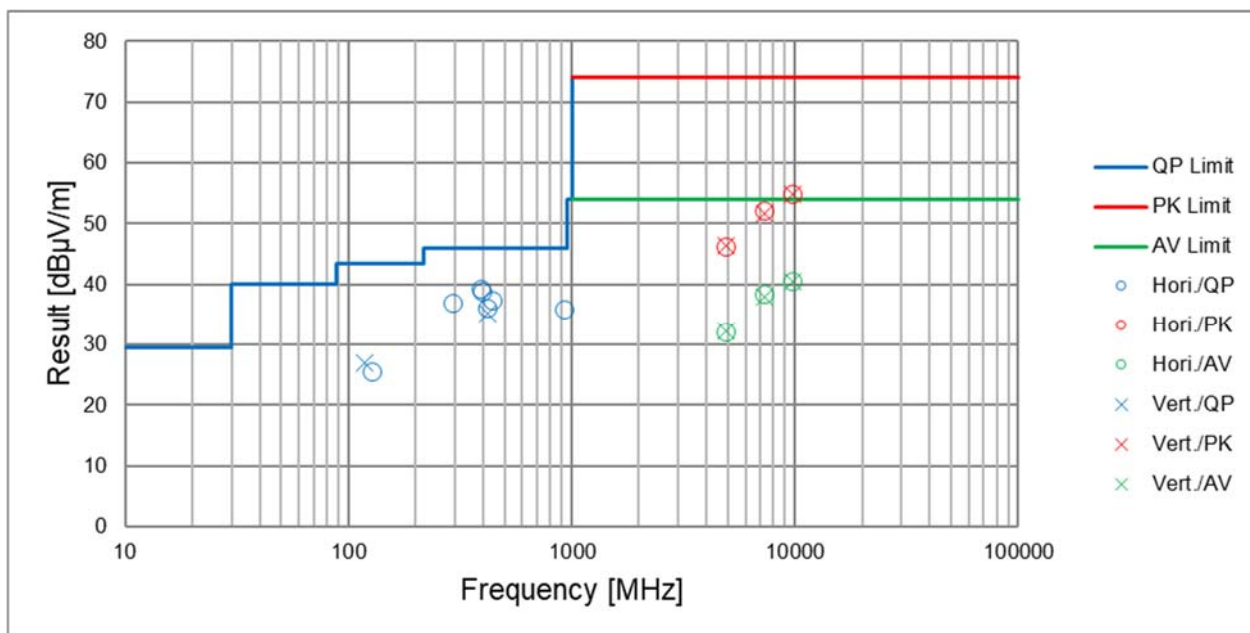
Shonan EMC Lab.
WAC1
January 21, 2025
21 deg. C / 42 % RH
Kouki Yamada
Tx, Hopping Off, 3DH5 2480 MHz



* The measurement was conducted for a sufficiently long enough time to detect any possible spurious emissions.
Final result of restricted band edge was shown in tabular data.

Radiated Spurious Emission (Plot data, Worst case mode for Maximum Peak Output Power)

Test place	Shonan EMC Lab.			
Semi Anechoic Chamber	WAC1	WAC1	WAC1	WAC1
Date	January 28, 2025	January 21, 2025	January 25, 2025	January 27, 2025
Temperature / Humidity	21 deg. C / 28 % RH	21 deg. C / 42 % RH	20 deg. C / 33 % RH	20 deg. C / 28 % RH
Engineer	Makoto Hosaka (30 MHz to 1 GHz)	Kouki Yamada (1 GHz to 10 GHz)	Masahide Ozaki (10 GHz to 18 GHz)	Takayuki Kobayashi (18 GHz to 26.5 GHz)
Mode	Tx, Hopping Off, DH5 2441 MHz			



*These plots data contain sufficient number to show the trend of characteristic features for EUT.

Radiated Spurious Emission

Test place	Shonan EMC Lab.		
Semi Anechoic Chamber	WAC1	WAC1	WAC1
Date	January 29, 2025	January 28, 2025	January 27, 2025
Temperature / Humidity	23 deg. C / 31 % RH	21 deg. C / 28 % RH	21 deg. C / 32 % RH
Engineer	Makoto Hosaka	Makoto Hosaka	Makoto Hosaka
	(30 MHz to 1 GHz)	(1 GHz to 10 GHz)	(10 GHz to 26.5 GHz)
Mode	Tx, Hopping Off, DH5 2480 MHz with 11ac-80 5775 MHz		

(* PK: Peak, AV: Average, QP: Quasi-Peak)

Polarity	Frequency	Detector	Reading	Ant.Fac.	Loss	Gain	Distance	Result	Limit	Margin	Height	Angle	Remark
	[MHz]		[dBuV]	[dB/m]	[dB]	[dB]	Fac. [dB]	[dBuV/m]	[dBuV/m]	[dB]	[cm]	[deg.]	
Hori.	128.003	QP	29.80	11.12	6.77	28.35	0.00	19.34	43.5	24.1	326	281	-
Hori.	294.914	QP	42.80	13.59	7.48	27.76	0.00	36.11	46.0	9.8	157	306	-
Hori.	393.214	QP	45.40	15.52	7.77	28.37	0.00	40.32	46.0	5.6	100	258	-
Hori.	400.001	QP	44.40	15.74	7.80	28.42	0.00	39.52	46.0	6.4	100	257	-
Hori.	420.003	QP	34.70	16.00	7.85	28.53	0.00	30.02	46.0	15.9	100	164	-
Hori.	442.369	QP	40.90	16.31	7.91	28.65	0.00	36.47	46.0	9.5	100	271	-
Hori.	933.008	QP	34.40	21.87	8.89	28.14	0.00	37.02	46.0	8.9	122	13	-
Hori.	4960.000	PK	51.80	32.62	-28.23	-	2.26	58.45	73.9	15.4	178	200	-
Hori.	7440.000	PK	47.32	36.69	-35.67	-	2.26	50.60	73.9	23.3	150	0	Floor Noise
Hori.	9920.000	PK	47.27	37.93	-33.99	-	2.26	53.47	73.9	20.4	150	0	Floor Noise
Hori.	4960.000	AV	34.33	32.62	-28.23	-	2.26	40.98	53.9	12.9	178	200	VBW:500 Hz
Hori.	7440.000	AV	33.48	36.69	-35.67	-	2.26	36.76	53.9	17.1	150	0	VBW:500 Hz, Floor Noise
Hori.	9920.000	AV	33.41	37.93	-33.99	-	2.26	39.61	53.9	14.2	150	0	VBW:500 Hz, Floor Noise
Vert.	117.691	QP	41.90	10.58	6.78	28.40	0.00	30.86	43.5	12.6	100	299	-
Vert.	420.007	QP	38.70	16.00	7.85	28.53	0.00	34.02	46.0	11.9	128	124	-
Vert.	4960.000	PK	51.81	32.62	-28.23	-	2.26	58.46	73.9	15.4	170	60	-
Vert.	7440.000	PK	47.95	36.69	-35.67	-	2.26	51.23	73.9	22.6	150	0	Floor Noise
Vert.	9920.000	PK	47.30	37.93	-33.99	-	2.26	53.50	73.9	20.4	150	0	Floor Noise
Vert.	4960.000	AV	34.33	32.62	-28.23	-	2.26	40.98	53.9	12.9	170	60	VBW:500 Hz
Vert.	7440.000	AV	34.38	36.69	-35.67	-	2.26	37.66	53.9	16.2	150	0	VBW:500 Hz, Floor Noise
Vert.	9920.000	AV	33.48	37.93	-33.99	-	2.26	39.68	53.9	14.2	150	0	VBW:500 Hz, Floor Noise

Result = Reading + Ant.Fac. + Loss (Cable + (Atten or Filter)(below 18 GHz) - Gain(Amp) (1 GHz to 18 GHz)) - Gain(Amp) (only below 1 GHz & above 18 GHz) + Distance Fac.

*Other frequency noises omitted in this report were not seen or have enough margin (more than 20 dB).

Distance Fac. : 1 GHz to 10 GHz : $20\log(3.89[m]/3.0[m]) = 2.26[dB]$

10 GHz to 40 GHz : $20\log(1.00[m]/3.0[m]) = -9.54[dB]$

Radiated Spurious Emission

Test place Shonan EMC Lab.
Semi Anechoic Chamber WAC1
Date January 28, 2025
Temperature / Humidity 21 deg. C / 28 % RH
Engineer Makoto Hosaka
(1 GHz to 2.8 GHz)
Mode Tx, Hopping Off, 3DH5 2480 MHz with 11ac-80 5775 MHz

(* PK: Peak, AV: Average, QP: Quasi-Peak)

Polarity	Frequency [MHz]	Detector	Reading [dBuV]	Ant.Fac. [dB/m]	Loss [dB]	Gain [dB]	Distance Fac. [dB]	Result [dBuV/m]	Limit [dBuV/m]	Margin [dB]	Height [cm]	Angle [deg.]	Remark
Hori.	2483.500	PK	48.15	27.96	-29.11	-	2.26	49.26	73.9	24.6	154	299	-
Hori.	2483.500	AV	34.18	27.96	-29.11	-	2.26	35.29	53.9	18.6	154	299	VBW:500 Hz
Vert.	2483.500	PK	48.03	27.96	-29.11	-	2.26	49.14	73.9	24.7	192	211	-
Vert.	2483.500	AV	34.08	27.96	-29.11	-	2.26	35.19	53.9	18.7	192	211	VBW:500 Hz

Result = Reading + Ant.Fac. + Loss (Cable + (Atten or Filter)(below 18 GHz) - Gain(Amp) (1 GHz to 18 GHz)) - Gain(Amp) (only below 1 GHz & above 18 GHz) + Distance Fac.

*Other frequency noises omitted in this report were not seen or have enough margin (more than 20 dB).

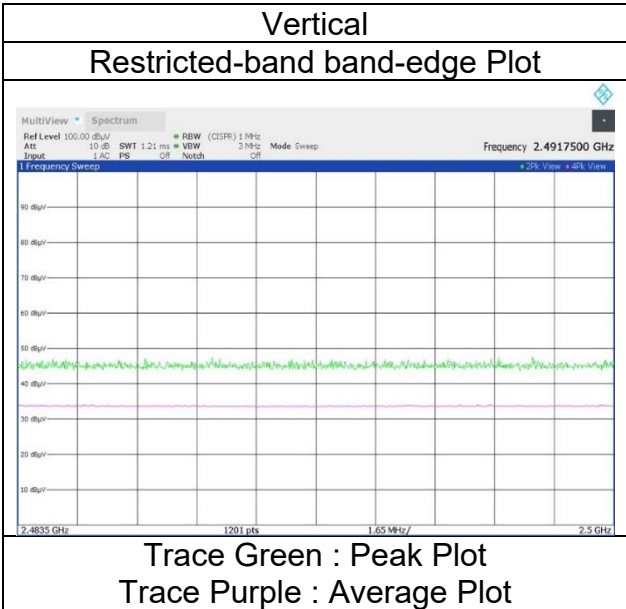
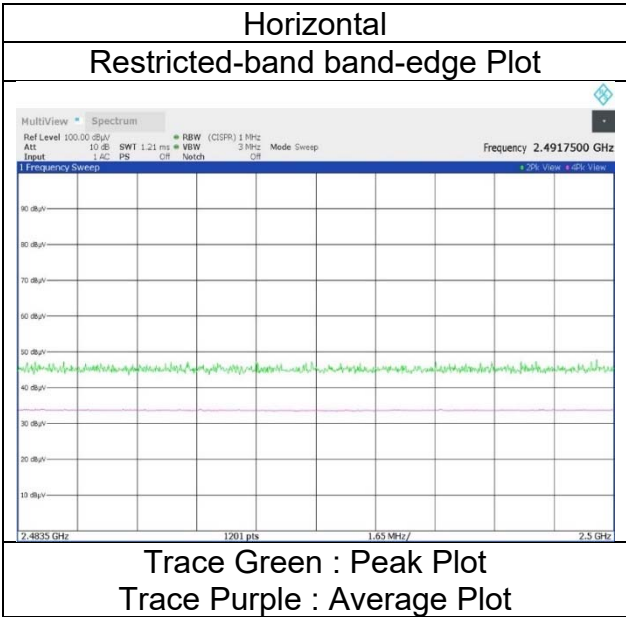
Distance Fac. : 1 GHz to 10 GHz : $20\log(3.89[m]/3.0[m]) = 2.26 [dB]$

10 GHz to 40 GHz : $20\log(1.00[m]/3.0[m]) = -9.54 [dB]$

Radiated Spurious Emission
(Reference Plot for band-edge)

Test place
Semi Anechoic Chamber
Date
Temperature / Humidity
Engineer
Mode

Shonan EMC Lab.
WAC1
January 28, 2025
21 deg. C / 28 % RH
Makoto Hosaka
Tx, Hopping Off, 3DH5 2480 MHz with 11ac-80 5775 MHz

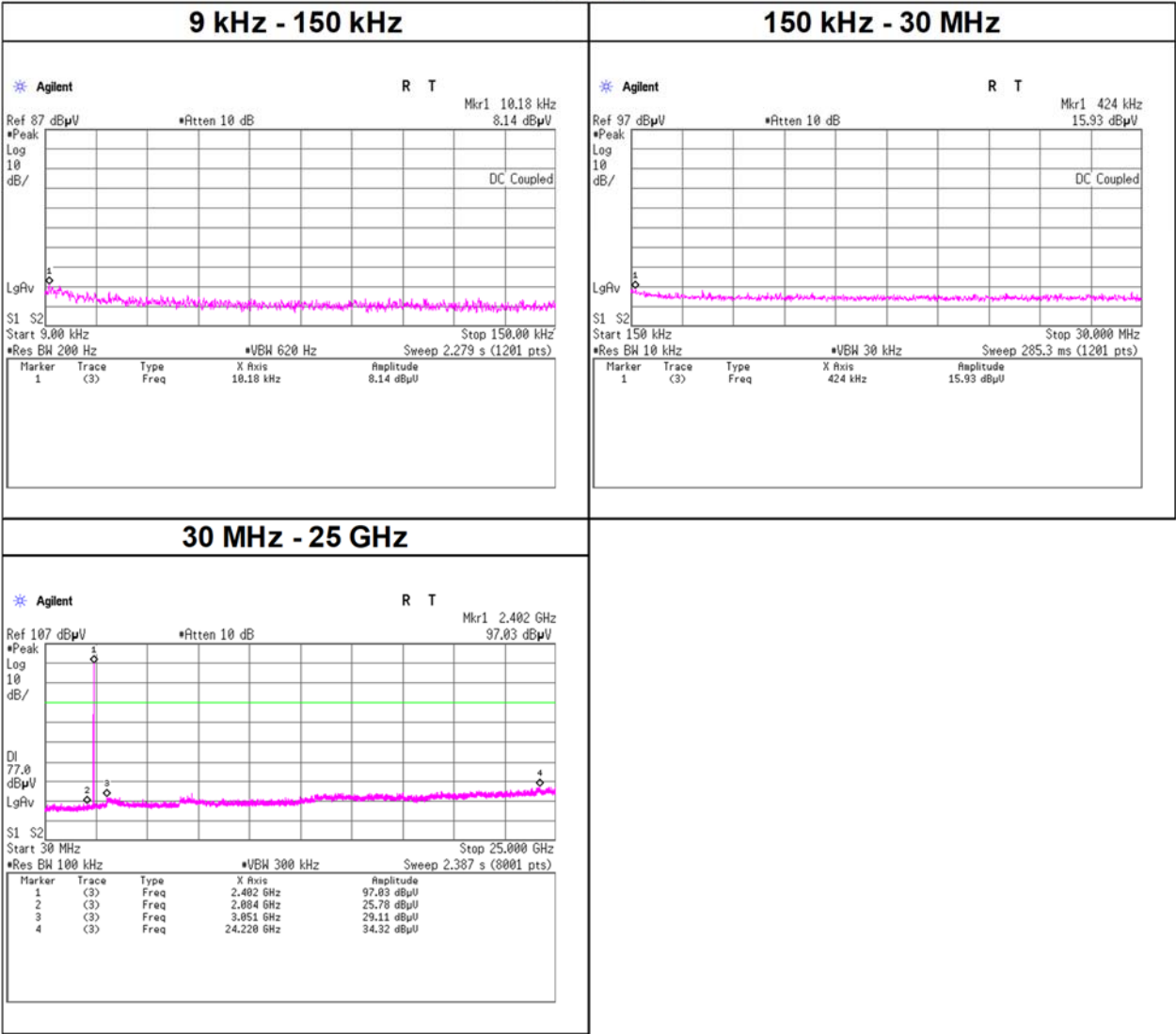


* The measurement was conducted for a sufficiently long enough time to detect any possible spurious emissions.
Final result of restricted band edge was shown in tabular data.

Conducted Spurious Emission

Test place Shonan EMC Lab. No.5 Shielded Room
Date January 19, 2025
Temperature / Humidity 17 deg. C / 31 % RH
Engineer Yohsuke Matsuzawa
Mode Tx, Hopping Off , DH5

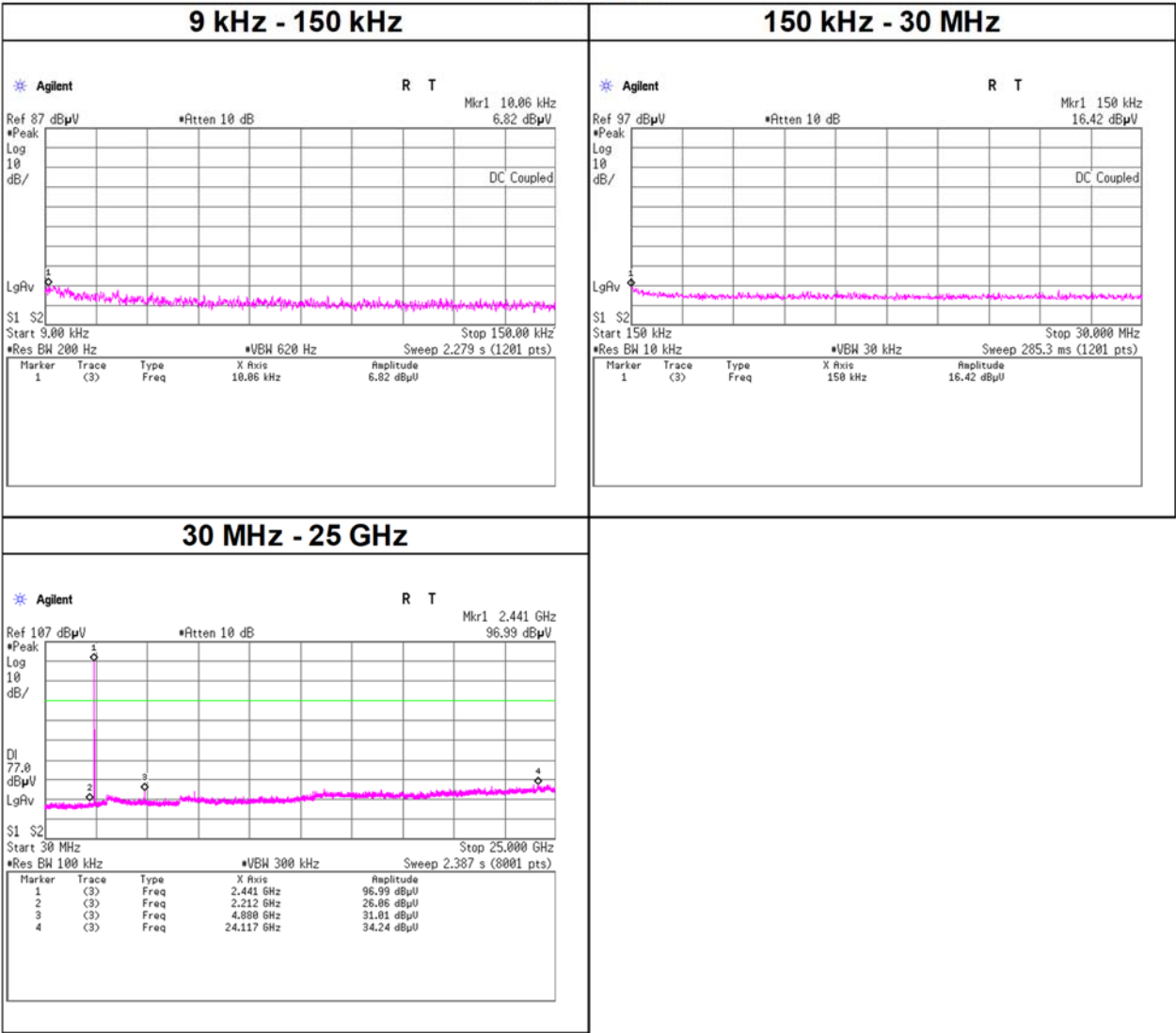
2402 MHz



Conducted Spurious Emission

Test place Shonan EMC Lab. No.5 Shielded Room
Date January 19, 2025
Temperature / Humidity 17 deg. C / 31 % RH
Engineer Yohsuke Matsuzawa
Mode Tx, Hopping Off , DH5

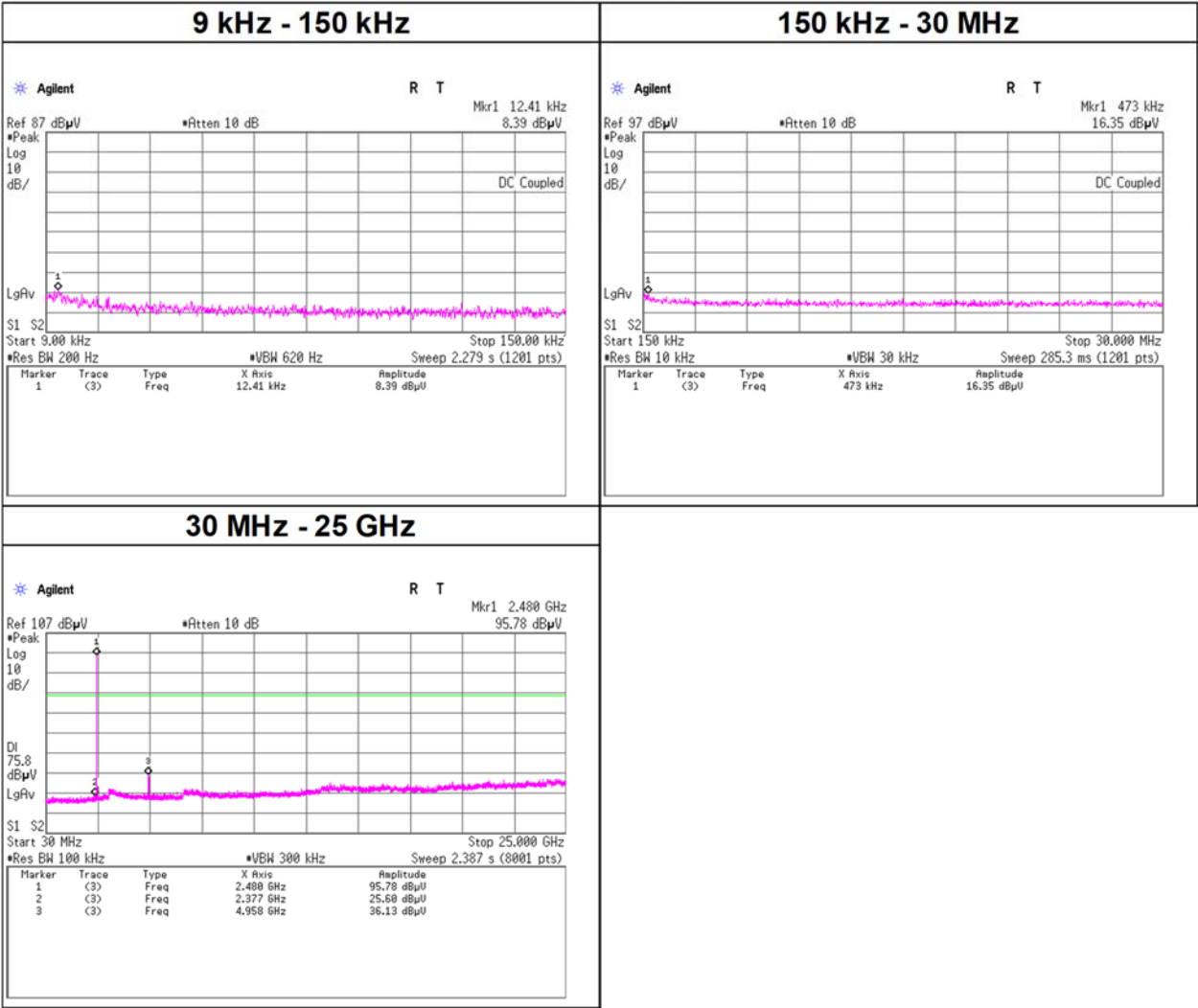
2441 MHz



Conducted Spurious Emission

Test place Shonan EMC Lab. No.5 Shielded Room
Date January 19, 2025
Temperature / Humidity 17 deg. C / 31 % RH
Engineer Yohsuke Matsuzawa
Mode Tx, Hopping Off , DH5

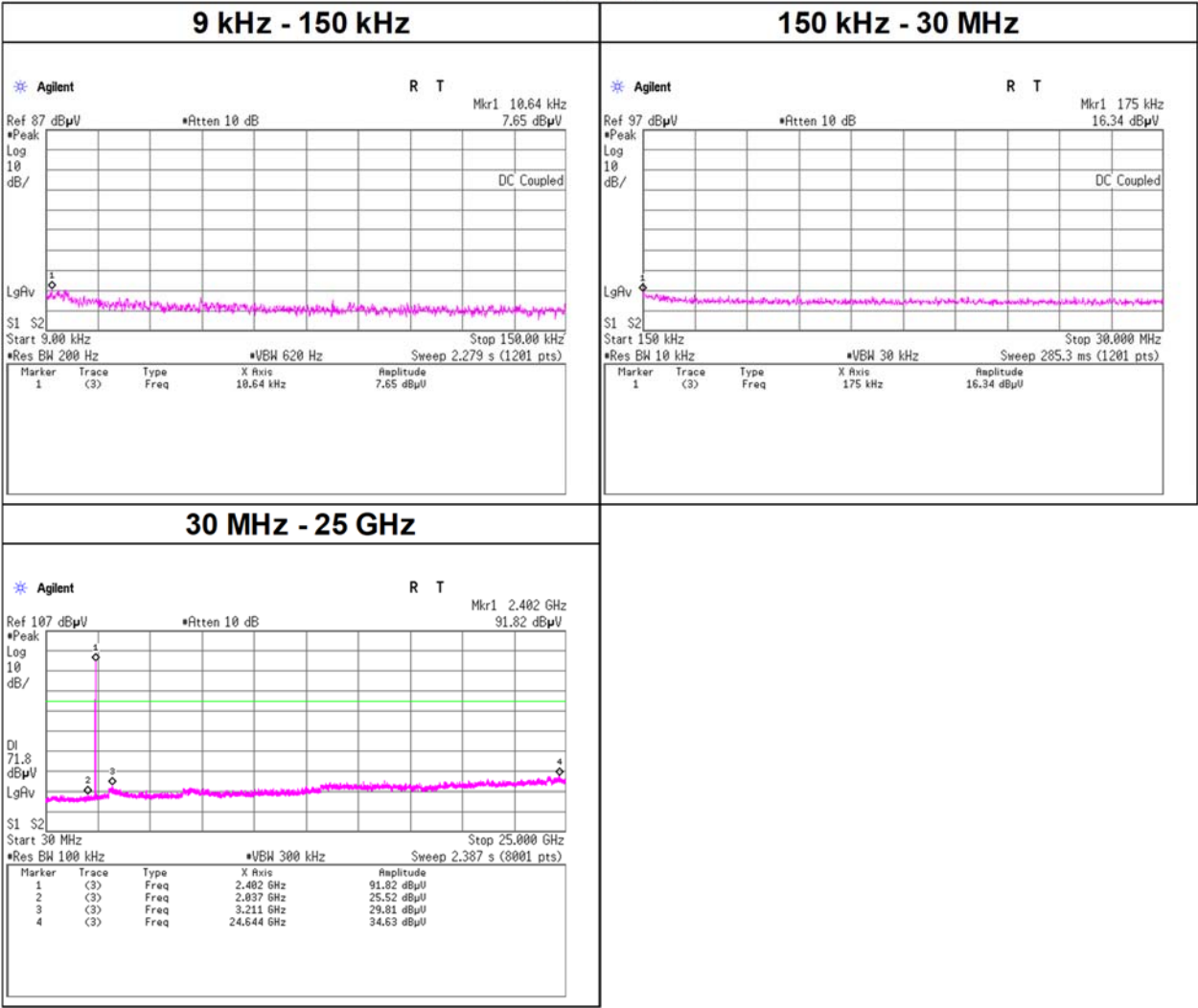
2480 MHz



Conducted Spurious Emission

Test place Shonan EMC Lab. No.5 Shielded Room
Date January 19, 2025
Temperature / Humidity 17 deg. C / 31 % RH
Engineer Yohsuke Matsuzawa
Mode Tx, Hopping Off , 3DH5

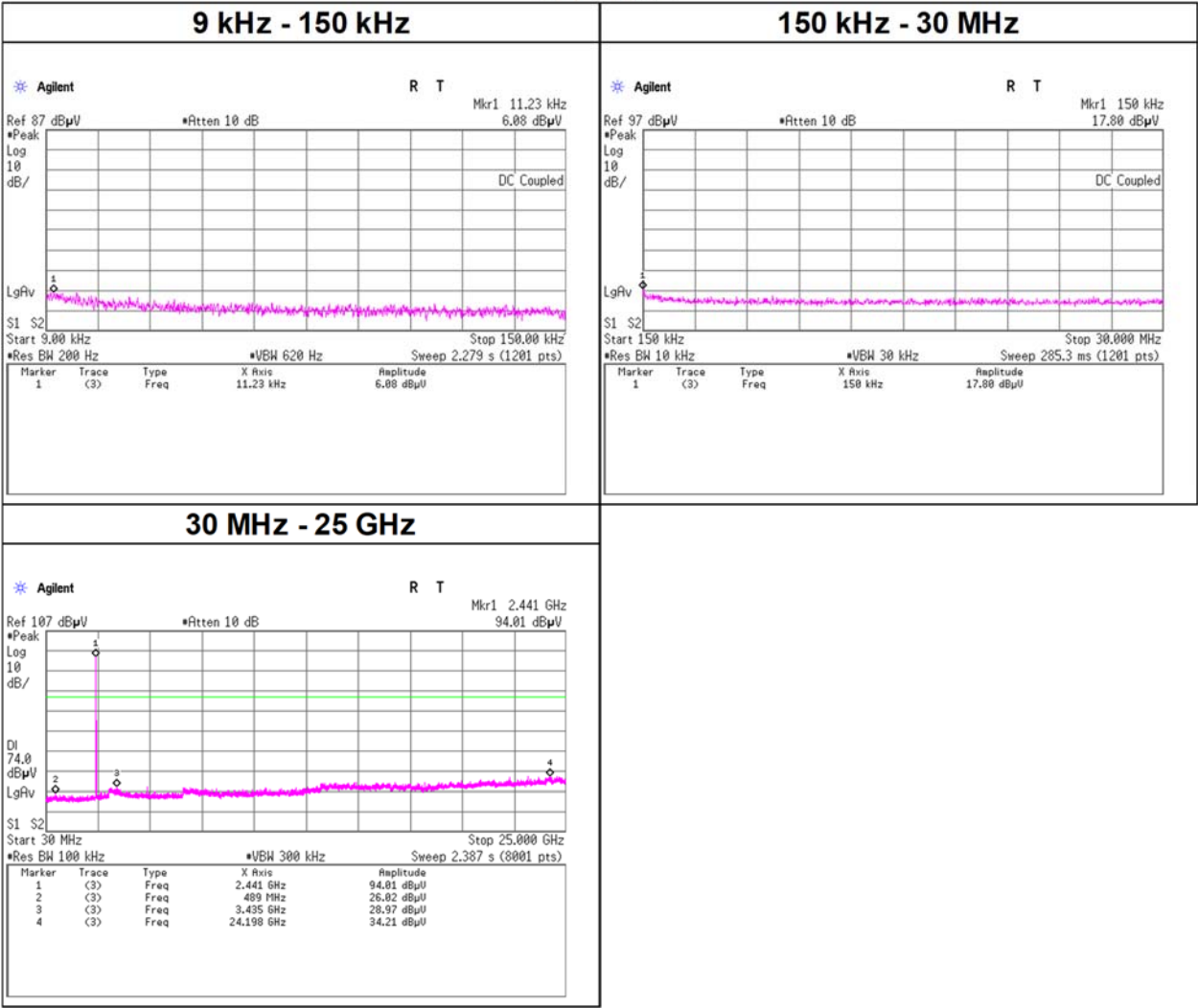
2402 MHz



Conducted Spurious Emission

Test place Shonan EMC Lab. No.5 Shielded Room
Date January 19, 2025
Temperature / Humidity 17 deg. C / 31 % RH
Engineer Yohsuke Matsuzawa
Mode Tx, Hopping Off , 3DH5

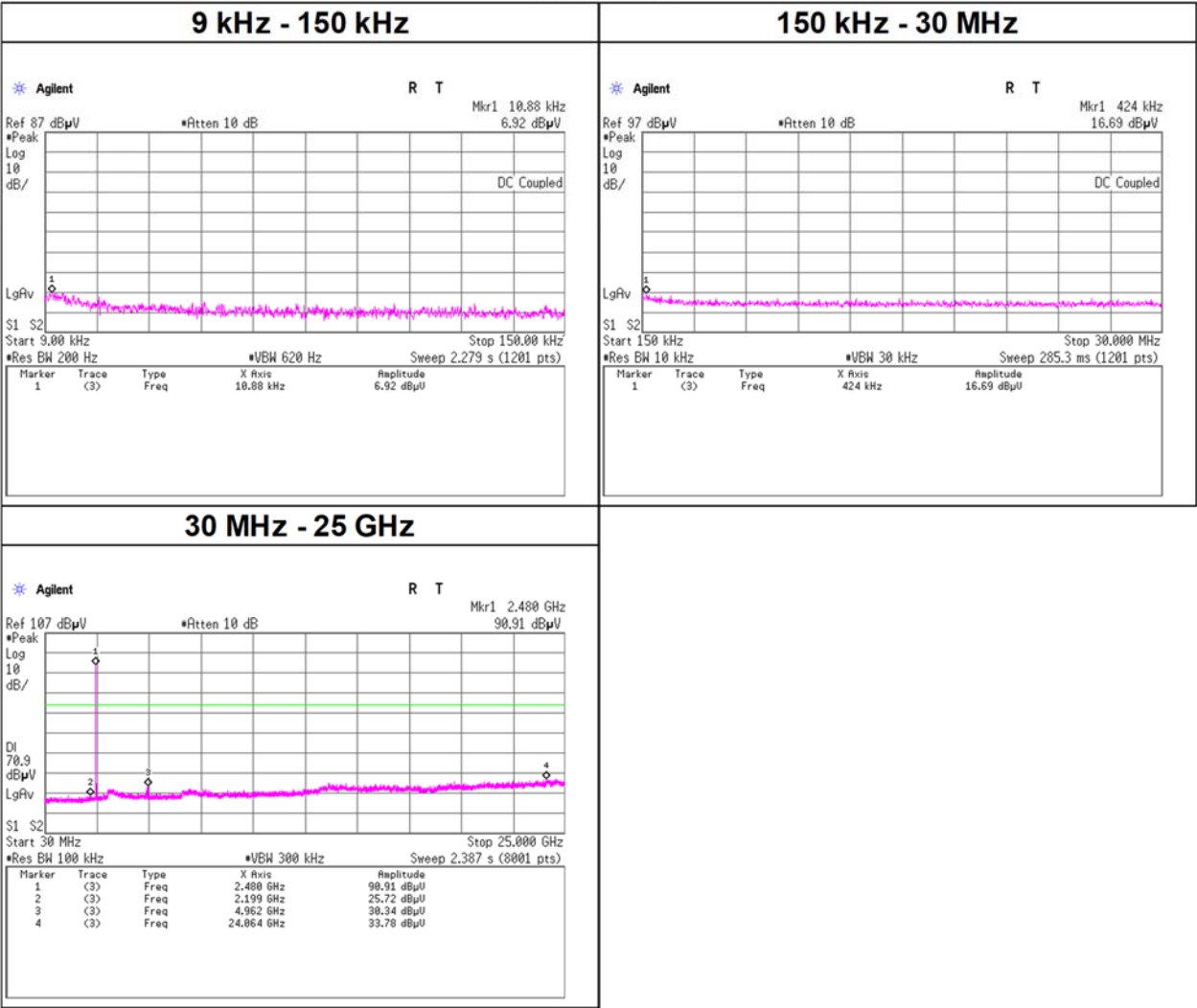
2441 MHz



Conducted Spurious Emission

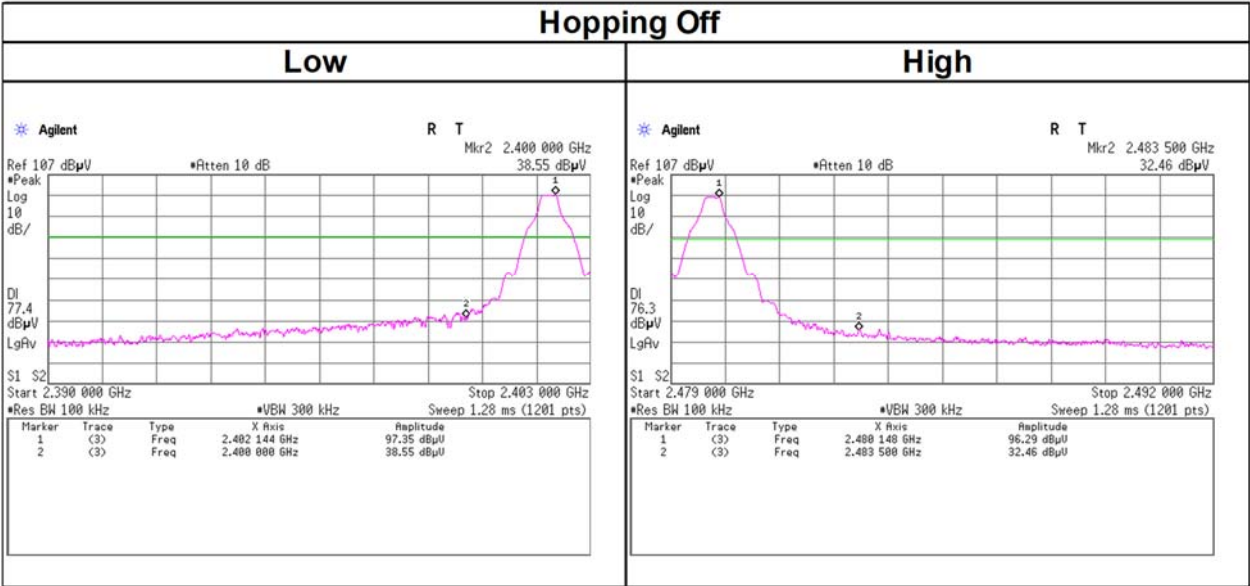
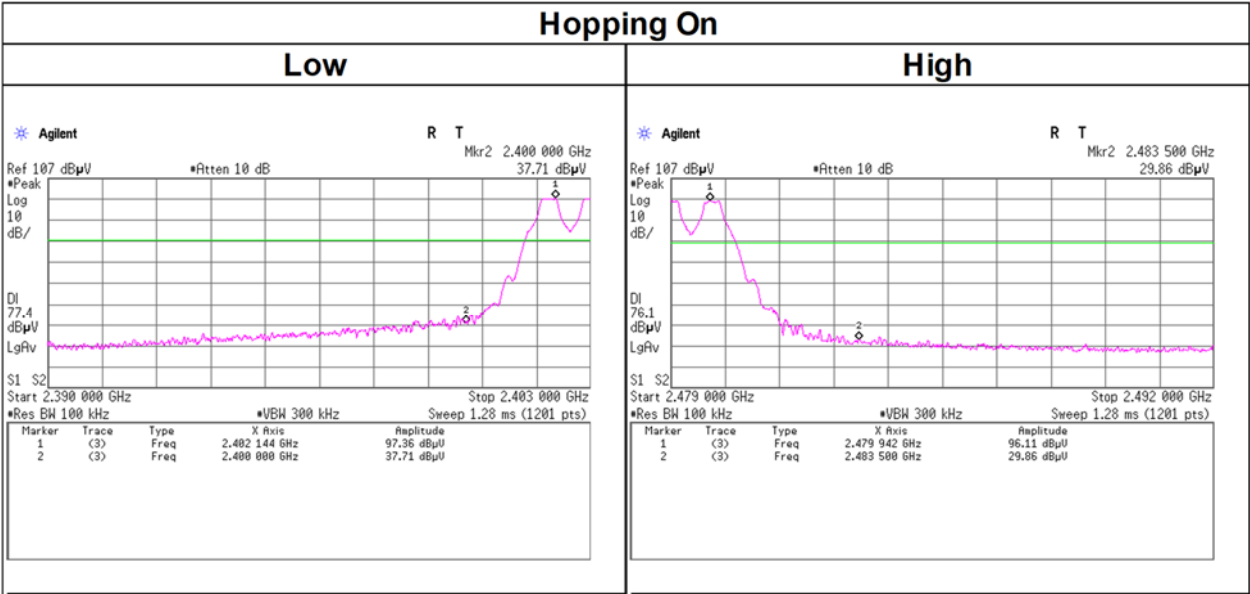
Test place Shonan EMC Lab. No.5 Shielded Room
Date January 19, 2025
Temperature / Humidity 17 deg. C / 31 % RH
Engineer Yohsuke Matsuzawa
Mode Tx, Hopping Off , 3DH5

2480 MHz



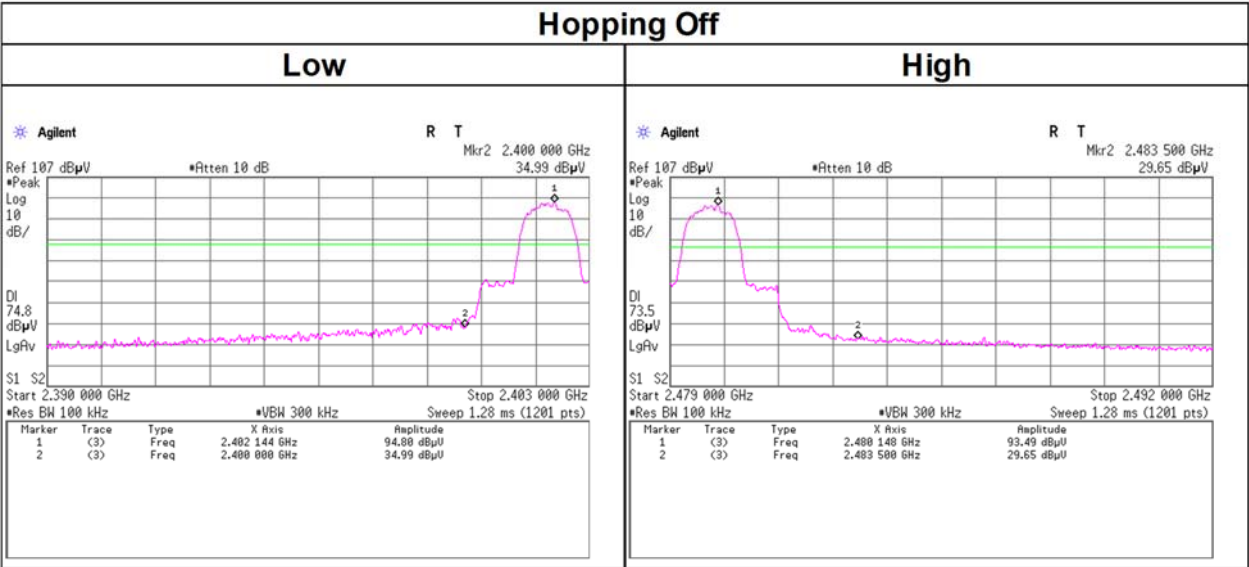
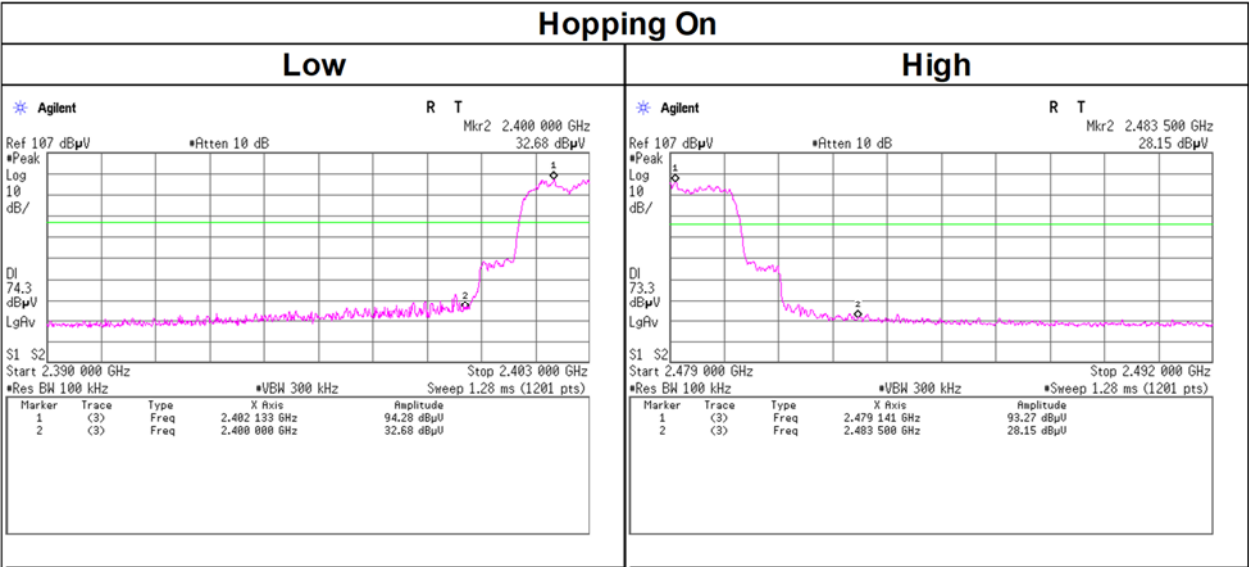
Conducted Emission Band Edge compliance

Test place Shonan EMC Lab. No.5 Shielded Room
Date January 22, 2025
Temperature / Humidity 21 deg. C / 40 % RH
Engineer Yosuke Murakami
Mode Tx DH5



Conducted Emission Band Edge compliance

Test place Shonan EMC Lab. No.5 Shielded Room
Date January 22, 2025
Temperature / Humidity 21 deg. C / 40 % RH
Engineer Yosuke Murakami
Mode Tx 3DH5



APPENDIX 2: Test Instruments

Test Equipment (1/2)

Test Item	LIMS ID	Description	Manufacturer	Model	Serial	Last Calibration Date	Cal Int
AT	145132	Attenuator	Weinschel Corp.	54A-10	W5692	2024/10/10	12
AT	160493	Attenuator	Weinschel Corp.	54A-10	83406	2024/12/03	12
AT	196947	Coaxial Cable	Huber+Suhner	SUCOFLEX 102	803478/2	2024/03/07	12
AT	239653	Coaxial Cable	Huber+Suhner	SUCOFLEX 102	2001221/2	2024/08/20	12
AT	146247	Power Meter	Keysight Technologies Inc	8990B	MY51000272	2024/05/14	12
AT	169910	Power Meter	Keysight Technologies Inc	8990B	MY51000448	2024/09/11	12
AT	146310	Power sensor	Keysight Technologies Inc	N1923A	MY5326009	2024/05/14	12
AT	169911	Power sensor	Keysight Technologies Inc	N1923A	MY57270004	2024/09/11	12
AT	235604	Spectrum Analyzer	Keysight Technologies Inc	E4440A	MY45300743	2024/05/23	12
AT	253774	Spectrum Analyzer	Keysight Technologies Inc	E4440A	MY46185398	2024/11/19	12
AT	242075	Terminator	Weinschel - API Technologies Corp	M1459A	121073	2024/11/06	12
AT	175822	Thermo-Hygrometer	CUSTOM. Inc	CTH-201	-	2024/08/11	12
RE	199784	Attenuator	JFW	50HF-006N	-	2024/06/14	12
RE	239786	Biconical Antenna	Schwarzbeck Mess-Elektronik OHG	VHBB 9124+BBA9106	01895	2024/08/10	12
RE	236708	Coaxial Cable	Hayashi-Repic co., Ltd.	NMS079B-GL310C-SMS117B-2m	47256-02-03	2024/05/09	12
RE	236710	Coaxial Cable	Hayashi-Repic co., Ltd.	KMS020B-GL140sE-KMS020B-7.0m	47256-03-01	2024/05/09	12
RE	236723	Coaxial Cable	Hayashi-Repic co., Ltd.	SF106(HUBER+SUHNER)/LMR400UF/GL310C/GL310C	2000429/47753-1/47256-01-03/47256-01-01	2024/05/09	12
RE	239643	Coaxial Cable	Junkosha	MWX221-01000NFSNMS/B	2306S021	2024/08/20	12
RE	243209	Coaxial Cable	Hayashi-Repic co., Ltd.	SMS13-13A26-NFS13-1.0m	49190-01-01	2024/12/05	12
RE	243687	Coaxial Cable	Hayashi-Repic co., Ltd.	NMS079B-GL310C-NMS079B-6.0m	49373-01-01	2024/12/05	12
RE	243689	Coaxial Cable	Huber+Suhner	GL310C(Hayashi-Repic)/SF106/SF106	49373-01-01/2000781/2001160	2024/12/17	12
RE	235639	DIGITAL MULTIMETER	HIOKI E.E. CORPORATION	DT4261	230313156	2024/05/29	12

Test Equipment (2/2)

Test Item	LIMS ID	Description	Manufacturer	Model	Serial	Last Calibration Date	Cal Int
RE	170932	EMI Software	TSJ (Techno Science Japan)	TEPTO-DV3(RE,CE,ME,PE)	Ver 3.1.0546	-	-
RE	145512	Horn Antenna	ETS-Lindgren	3160-09	00094868	2024/06/20	12
RE	236686	Horn Antenna	Schwarzbeck Mess-Elektronik OHG	BBHA 9120 C	787	2024/04/19	12
RE	236769	Horn Antenna	AINFO Inc.	LB-8180-NF	2030013000111	2024/04/19	12
RE	145527	Logperiodic Antenna	Schwarzbeck Mess-Elektronik OHG	VUSLP9111B	193	2024/04/10	12
RE	145007	Pre Amplifier	Toyo Corporation	HAP18-26W	19	2024/08/21	12
RE	145130	Pre Amplifier	Agilent Technologies	8447D	2944A09965	2024/07/10	12
RE	237784	RF RELAY MATRIX with preamplifier	TSJ (Techno Science Japan)	RFM-E221261R	07795	2024/11/12	12
RE	236212	Semi-Anechoic Chamber	TDK	SWAC-01(NSA)	1	2024/05/09	12
RE	236616	Semi-Anechoic Chamber	TDK	SWAC-01(SVSWR)	1	2024/06/04	12
RE	207280	Tape Measure	ASKUL	-	-	-	-
RE	235267	Test Receiver	Rohde & Schwarz	ESW44	103018	2024/03/05	12
RE	235735	Thermo-Hygrometer	CUSTOM. Inc	CTH-230	-	2024/04/28	12

*Hyphens for Last Calibration Date and Cal Int (month) are instruments that Calibration is not required (e.g. software), or instruments checked in advance before use.

The expiration date of the calibration is the end of the expired month.

As for some calibrations performed after the tested dates, those test equipment have been controlled by means of an unbroken chains of calibrations.

All equipment is calibrated with valid calibrations. Each measurement data is traceable to the national or international standards.

Test item:

AT: Antenna Terminal Conducted test

RE: Radiated Emission